

ST MC SDK 5.x 相电流检测与重构 位置、速度信息获取

STM32电动机控制应用系列讲座之三



life.augmented



STM32

STM32
Cube

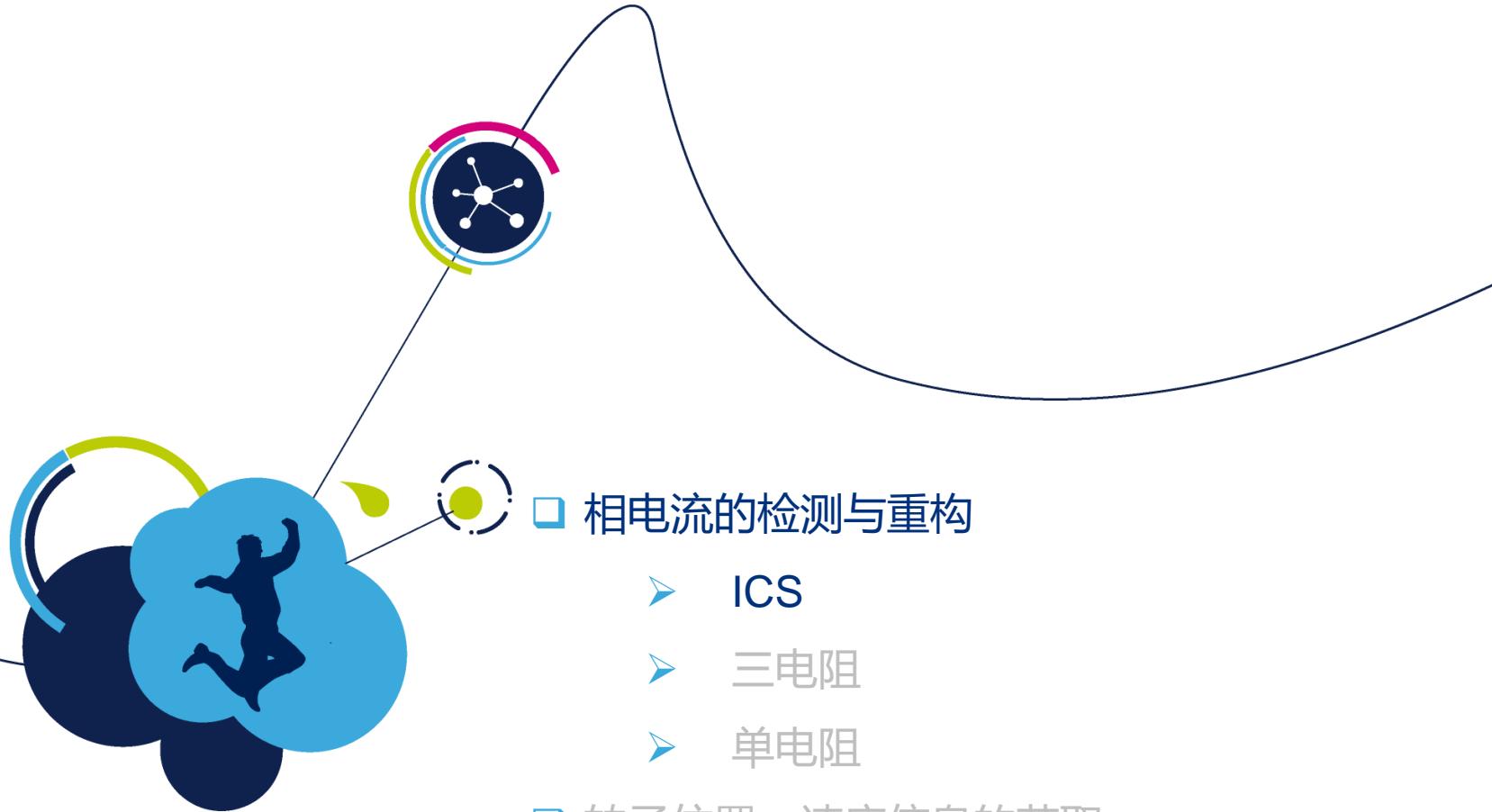
□ 相电流的检测与重构

- ICS
- 三电阻
- 单电阻

□ 转子位置、速度信息的获取

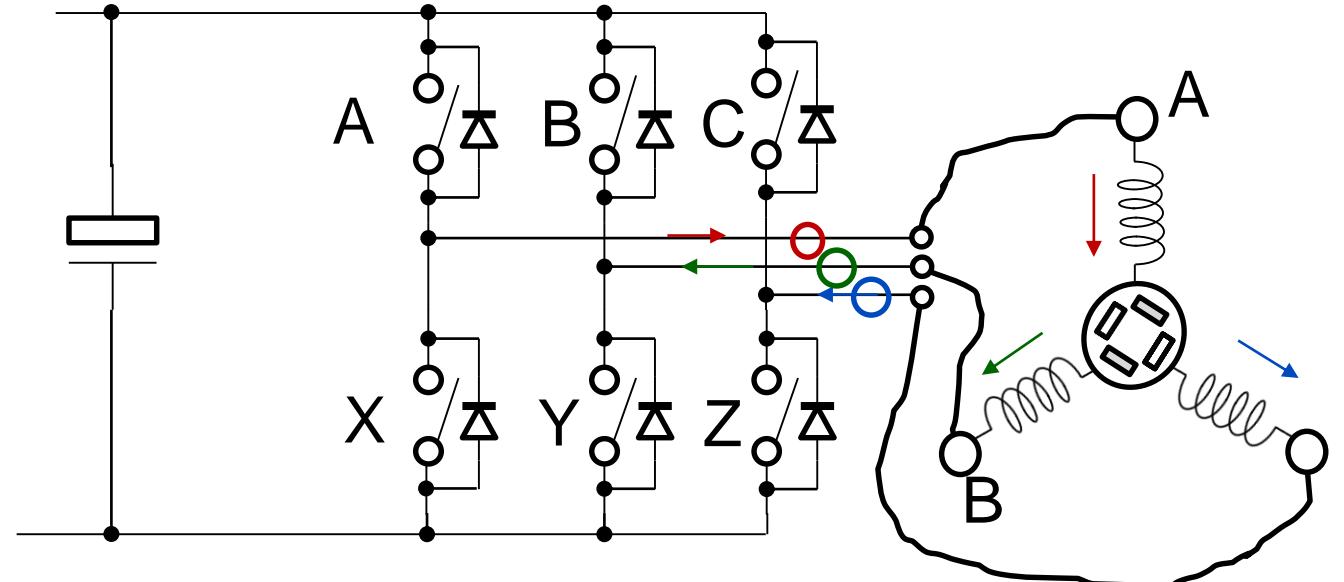
- 有位置传感器
- 无位置速度传感器

相电流的检测与重构

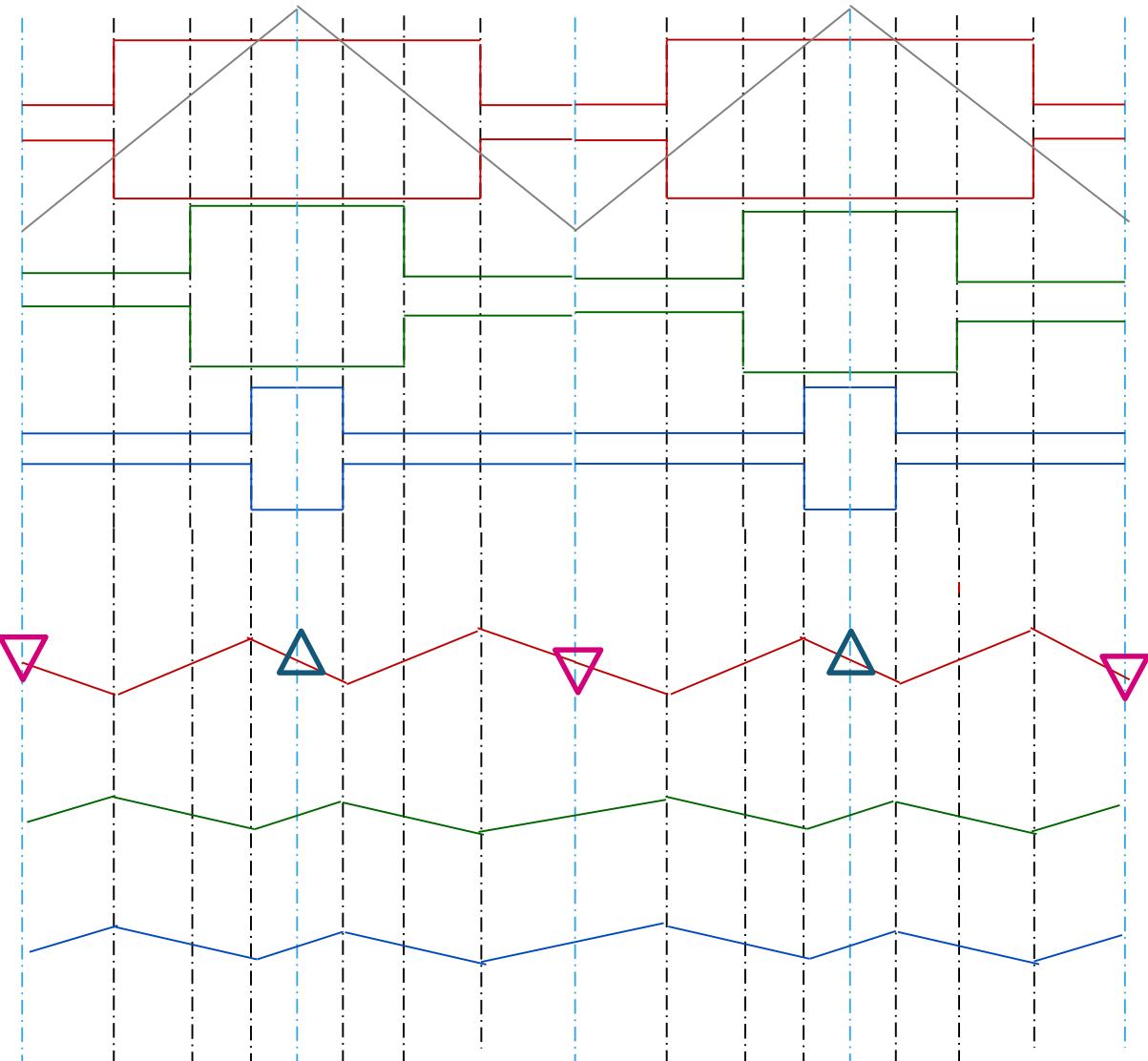
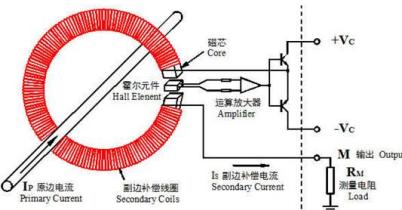
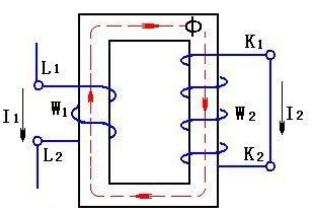


电流采样 — ICS

4



	ACCT	DCCT
频率范围	>0 Hz ~ tens kHz	DC ~ 100kHz
退磁	需要	不需要
成本	低	高



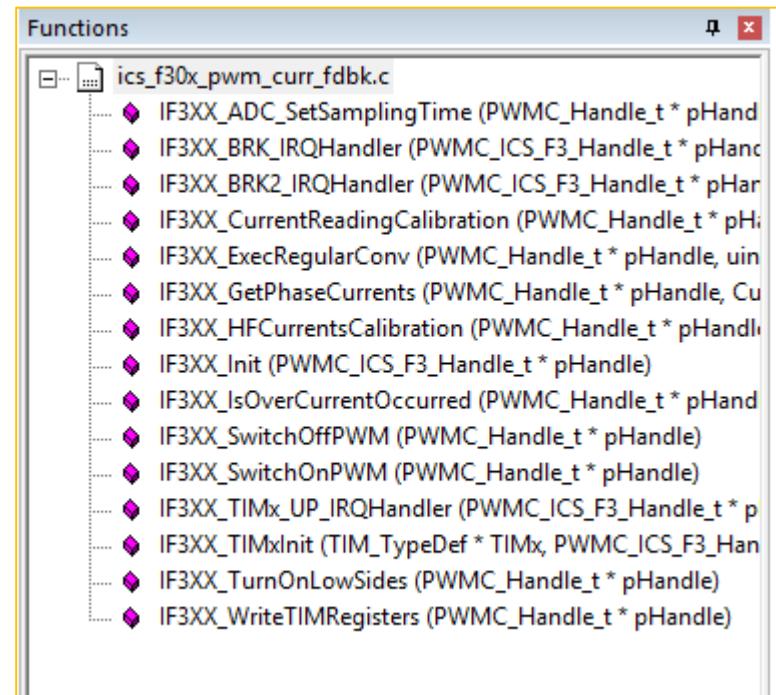
ST MC SDK5.x ICS采样固件

➤ 针对STM32系列芯片都有各自的文件：

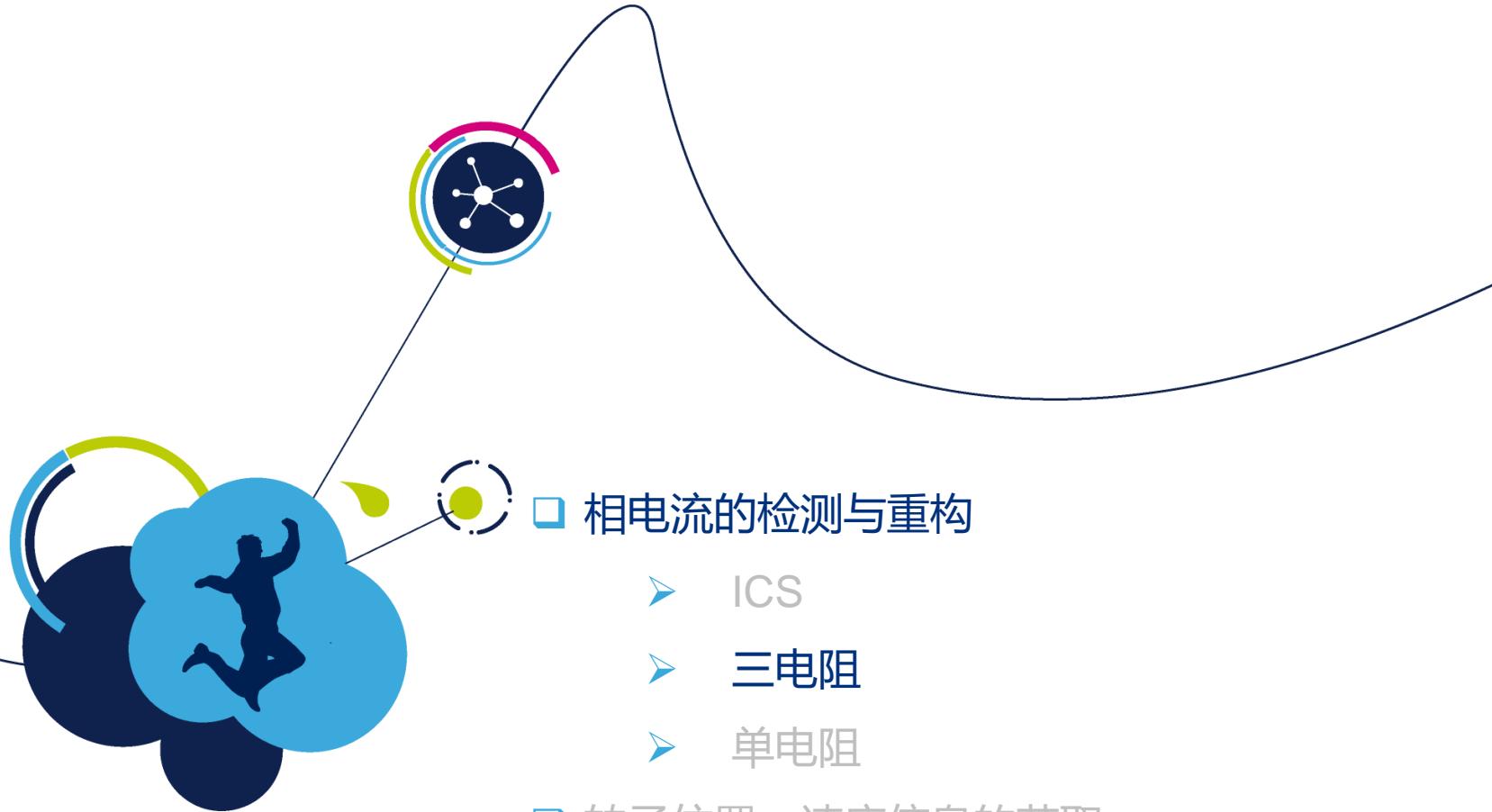
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F1xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F3xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F4xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F7xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\L4xx\Src

➤ 文件名称

- ✓ ics_yxx_pwm_curr_fdbk.c
- ✓ y=f1, f3, f4, f7, l4

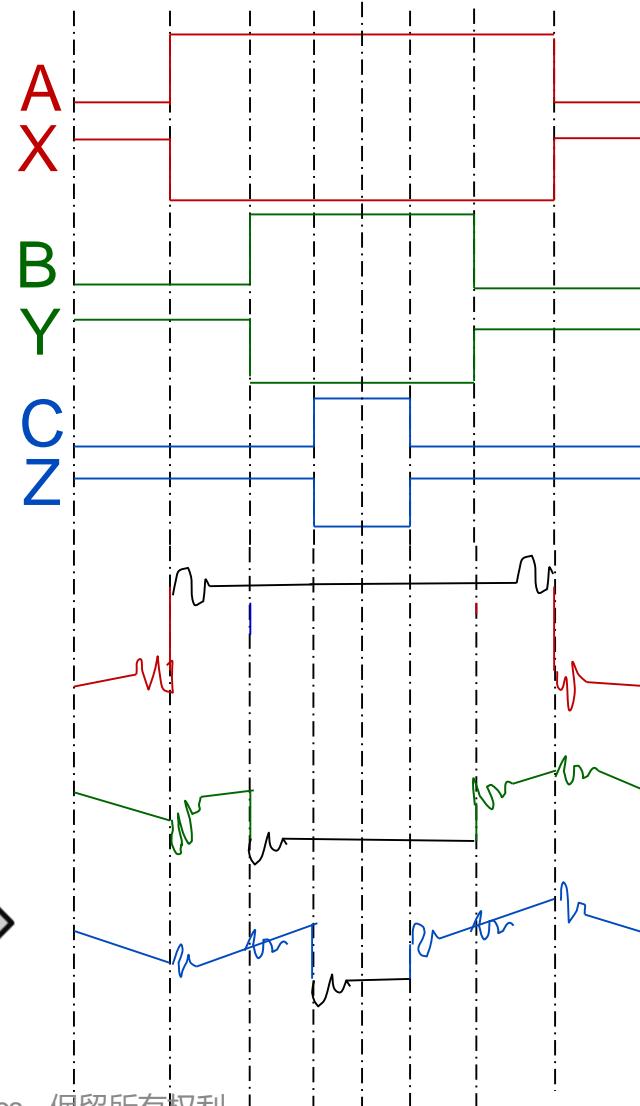
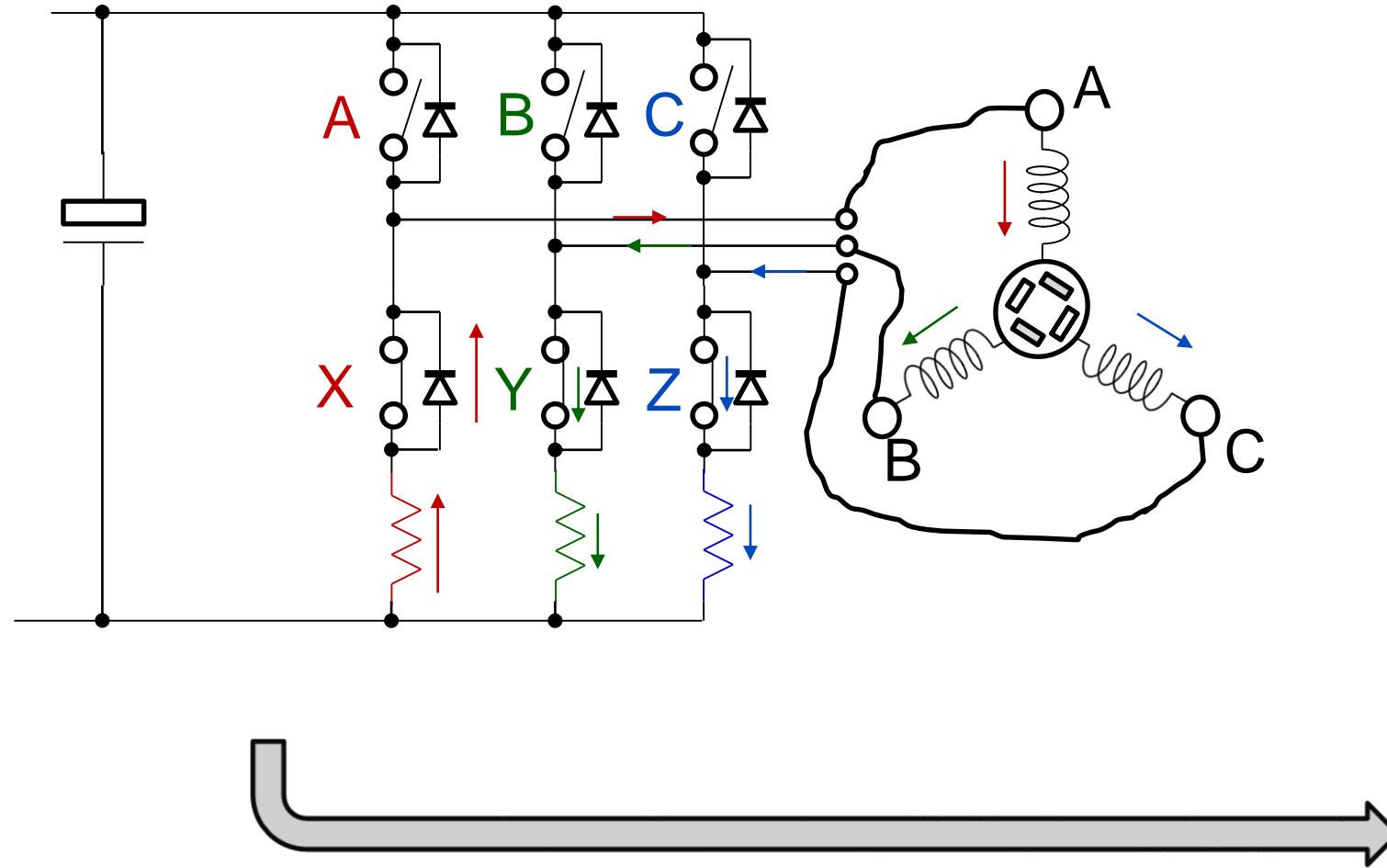


相电流的检测与重构



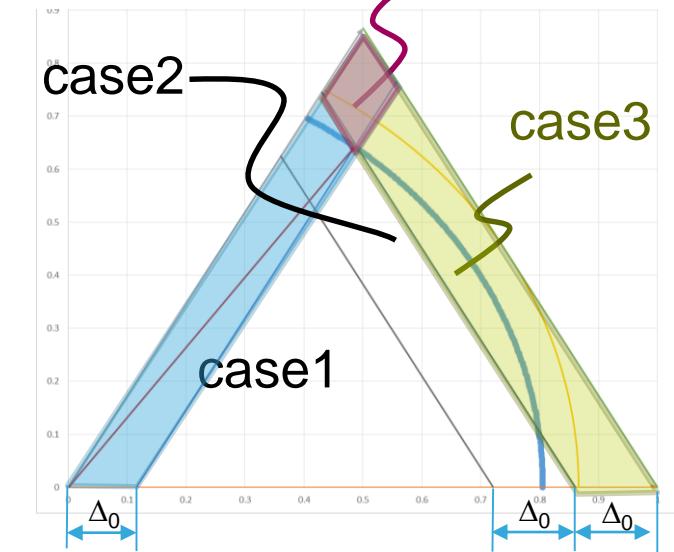
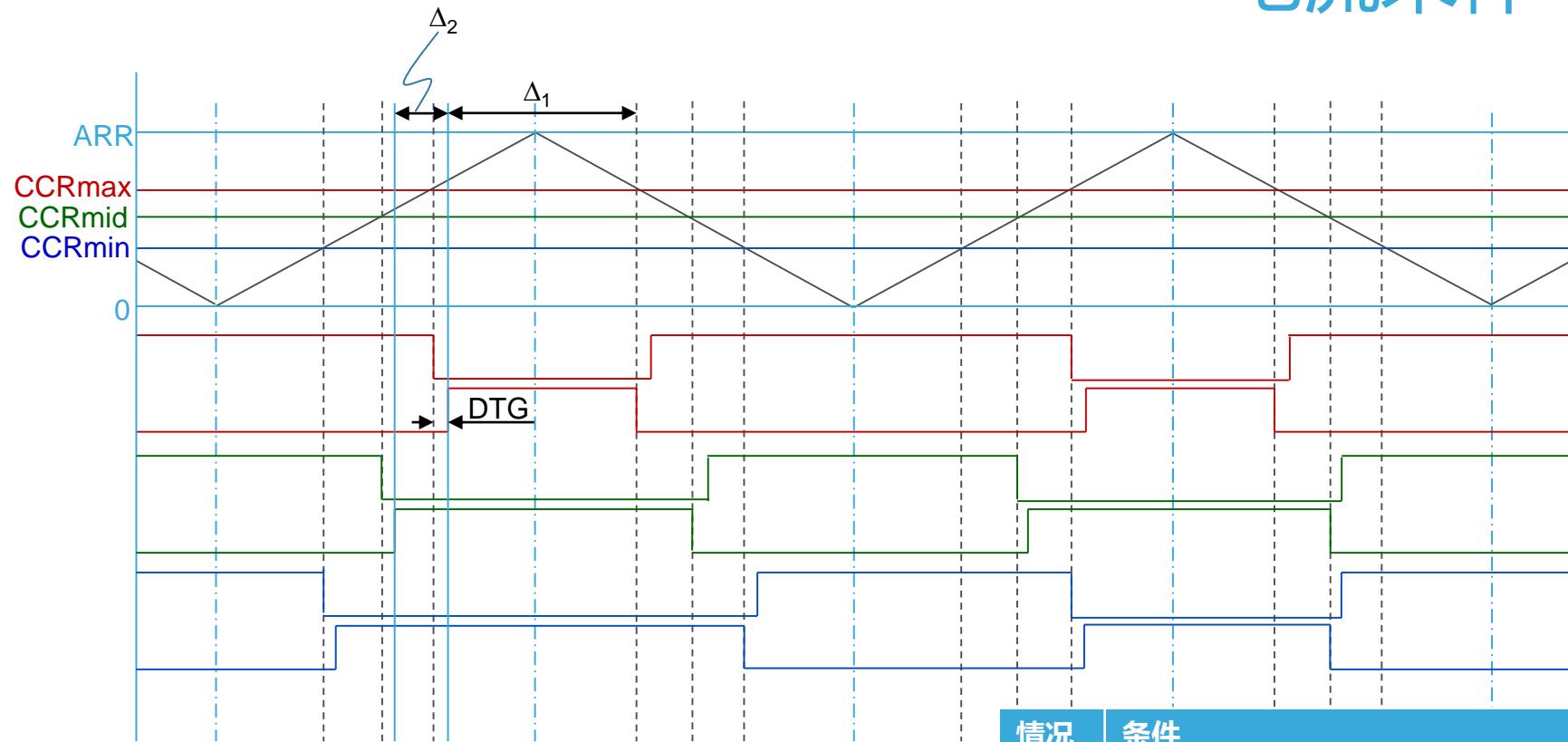
电流采样 — 三电阻(1/2)

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电流采样 – 三电阻(2/2)

case4



情况	条件	采样点
1	$\Delta_1 > \max(2^*(\text{CNT_Ton} + \text{CNT_Tring} + \text{CNT_TADCSH(COV)}), \text{CNT_TADCsta} + \text{CNT_TADCSH(COV)} - t_{dead}/2)$	Middle of PWM
2	$\Delta_1 > \Delta_0$	$\text{CCRmax} + t_{dead} + ton + tring + \epsilon$
3	$\Delta_2 > \Delta_0 > \Delta_1$	$\text{CCRmid} + t_{dead} + ton + tring + \epsilon$
4	$\Delta_1 < \Delta_0 \text{ and } \Delta_2 < \Delta_0$	Not available

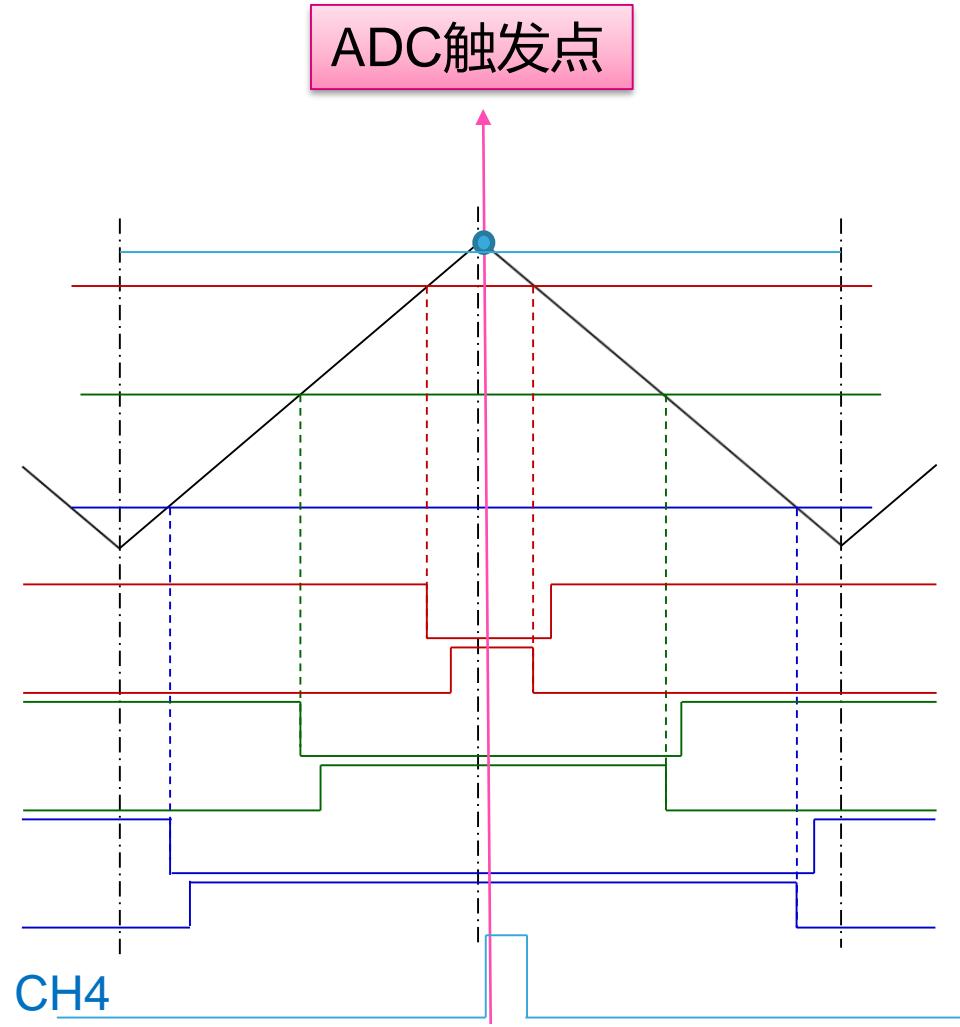
$$\Delta_1 = 2 * (\text{ARR} - \text{CCRmax} - \text{DTG})$$

$$\Delta_2 = \text{CCRmax} - \text{CCRmid}$$

$$\Delta_0 = \text{CNT_Ton} + \text{CNT_Tring} + \text{CNT_TADCSH(COV)}, \\ \text{Tring} > \text{TADCsta}$$

$$\Delta_0 = \text{CNT_Ton} + \text{CNT_TADCsta} + \text{CNT_TADCSH(COV)}, \text{TADCsta} \geq \text{Tring}$$

三电阻ADC触发机制说明



- 配置TIMER CH4为TRGO输出
- TIMER的TRGO输出用于硬件触发ADC采样；
- 如果是拥有两个ADC模块的可以同时触发进行同时采样
- 判断波形的采样位置，修正CCR4数据

ST MC SDK5.x 三电阻采样固件

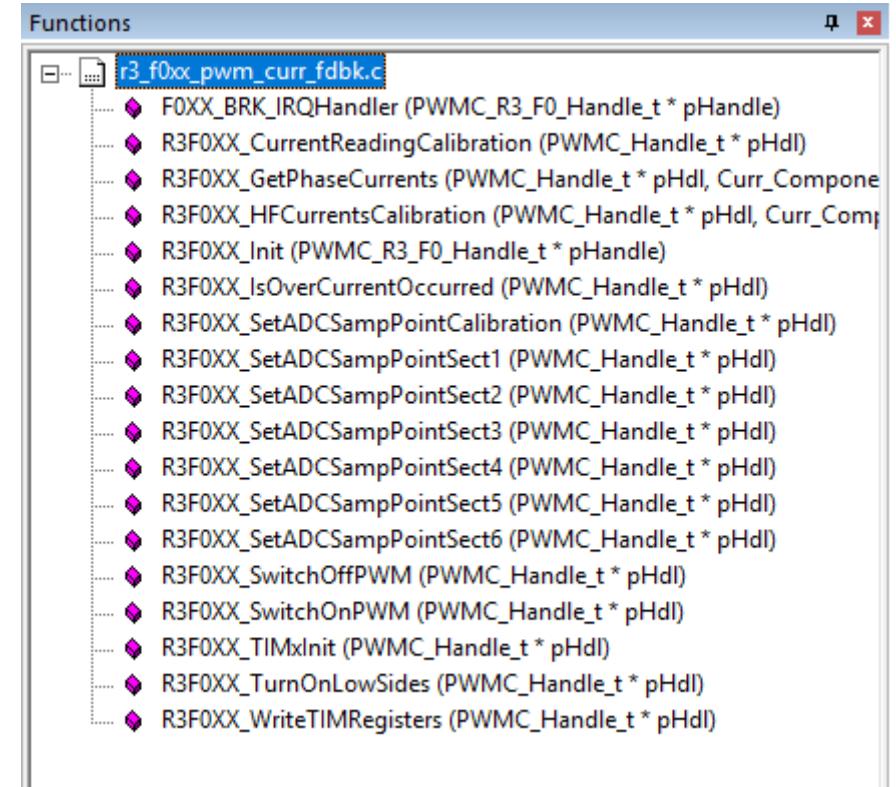
10

□ 针对STM32系列芯片都有各自的文件：

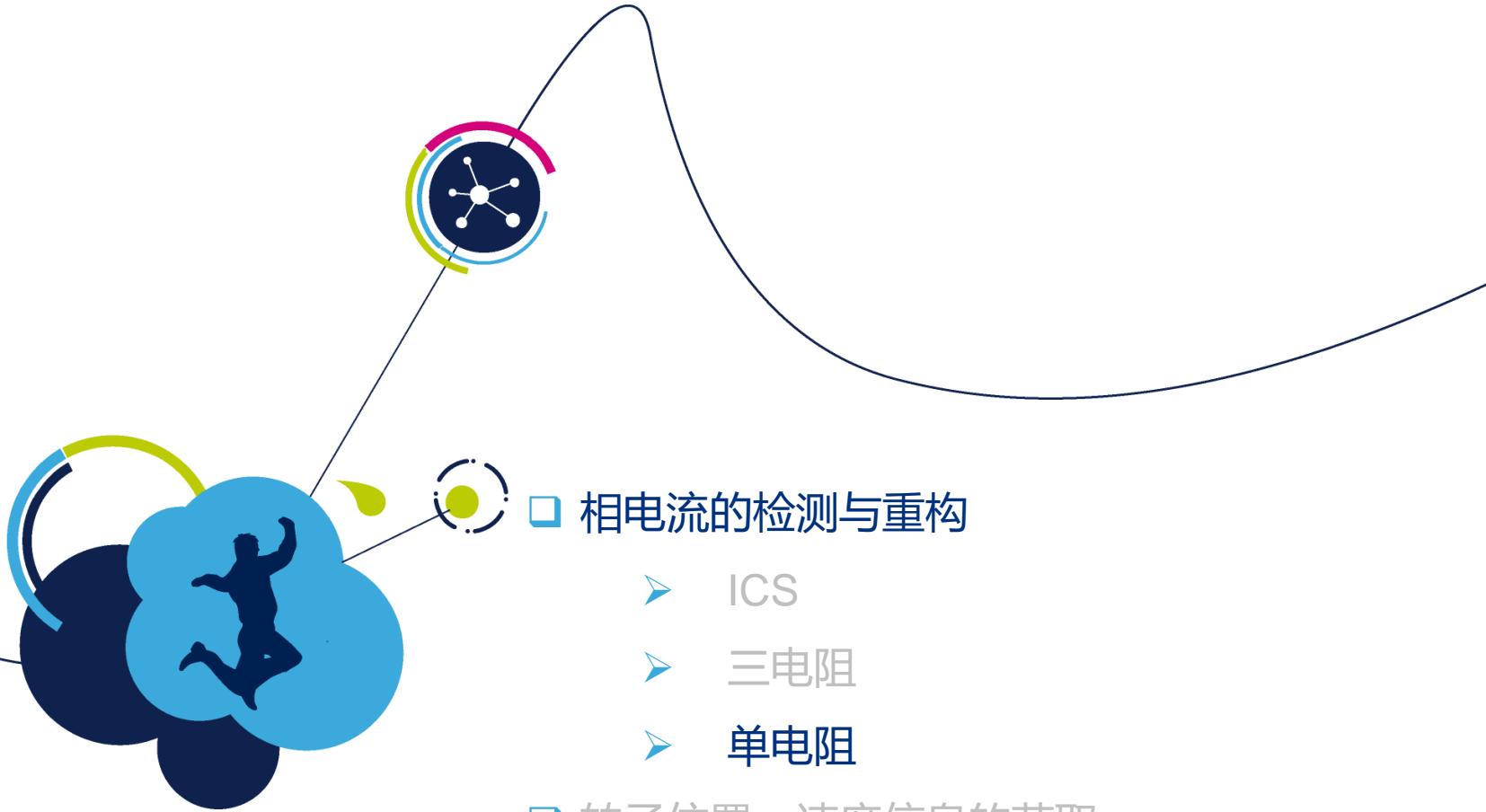
1. xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F0xx\Src
2. xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F1xx\Src
3. xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F3xx\Src
4. xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F4xx\Src
5. xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F7xx\Src
6. xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\L4xx\Src

□ 文件名称

- r3_z_yxx_pwm_curr_fdbk.c
 - ✓ y=f0, f1, f3, f4, f7, l4
 - ✓ z=1,4(for dual motor),[],.s

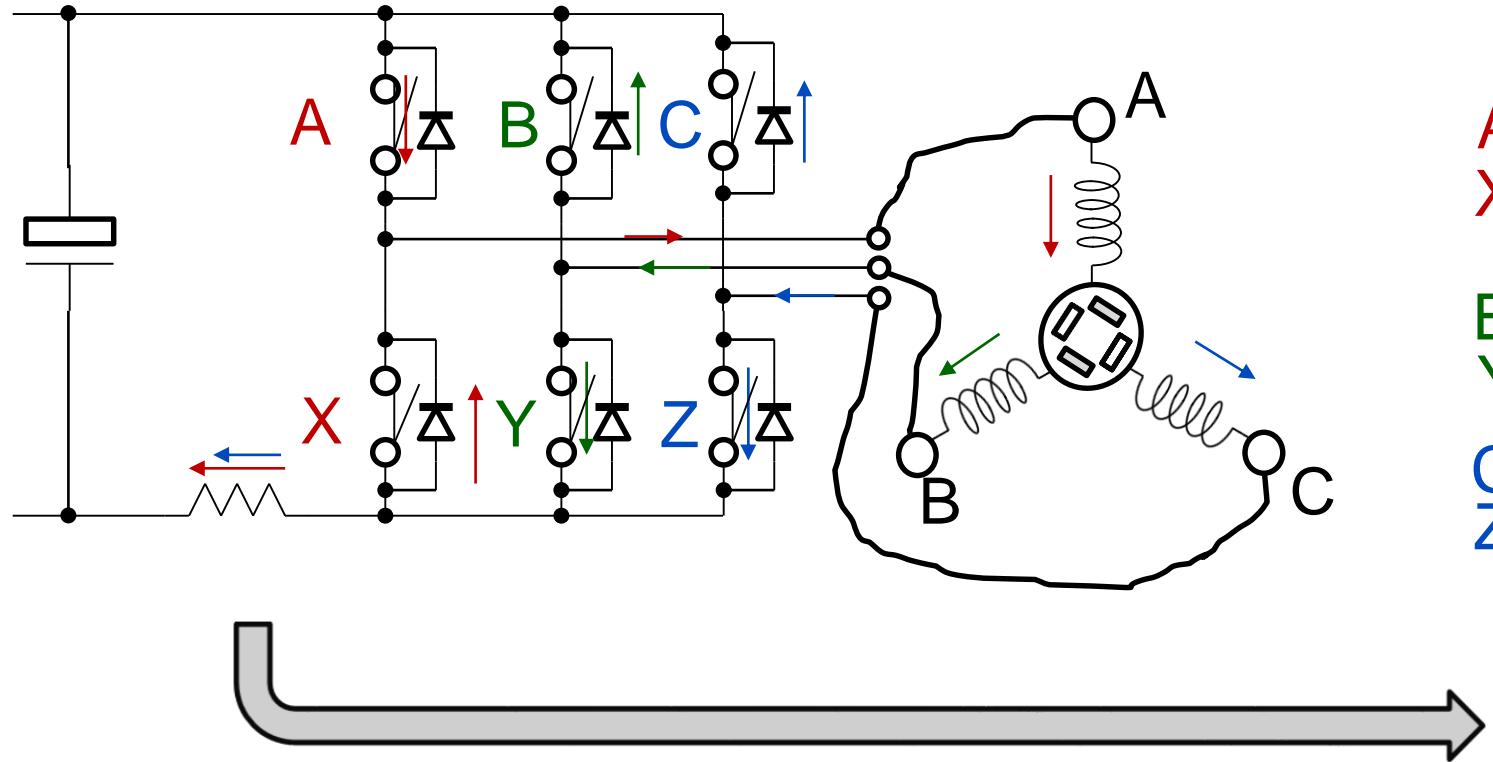


相电流的检测与重构

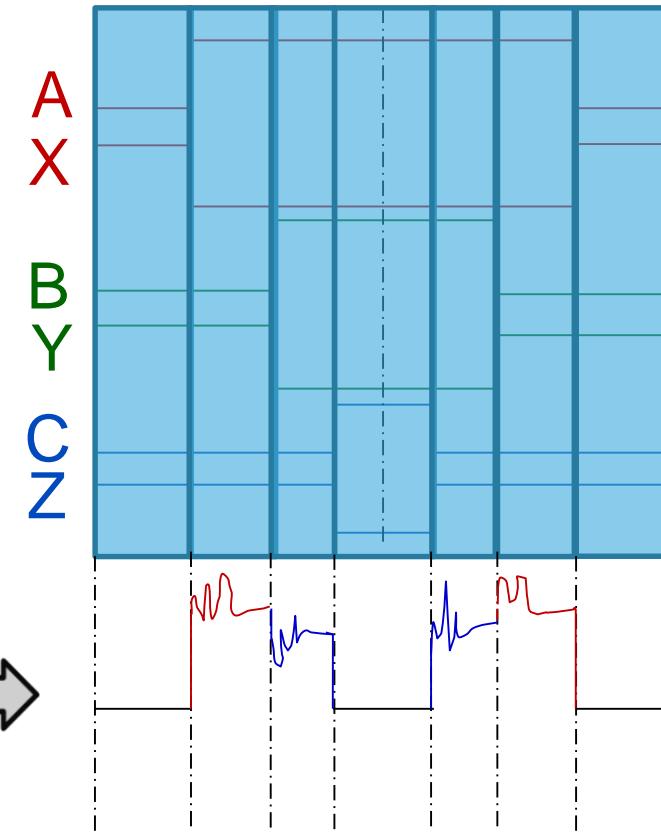


电流采样 — 单电阻(1/8)

12

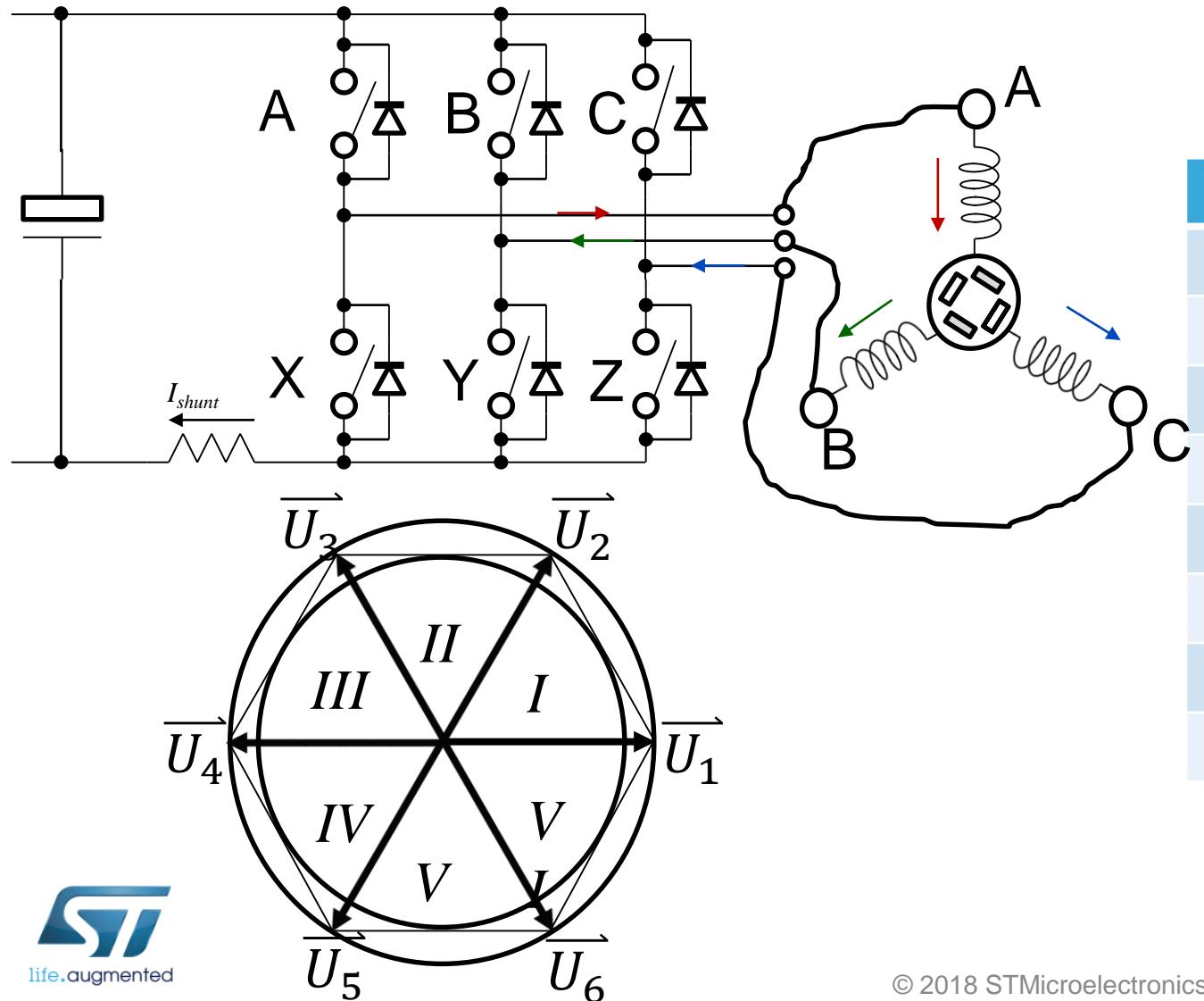


- 在一个PWM周期内采集两相电流数据
- 可根据 $I_a + I_b + I_c = 0$ 构造出三相电流



电流采样 — 单电阻(2/8)

13

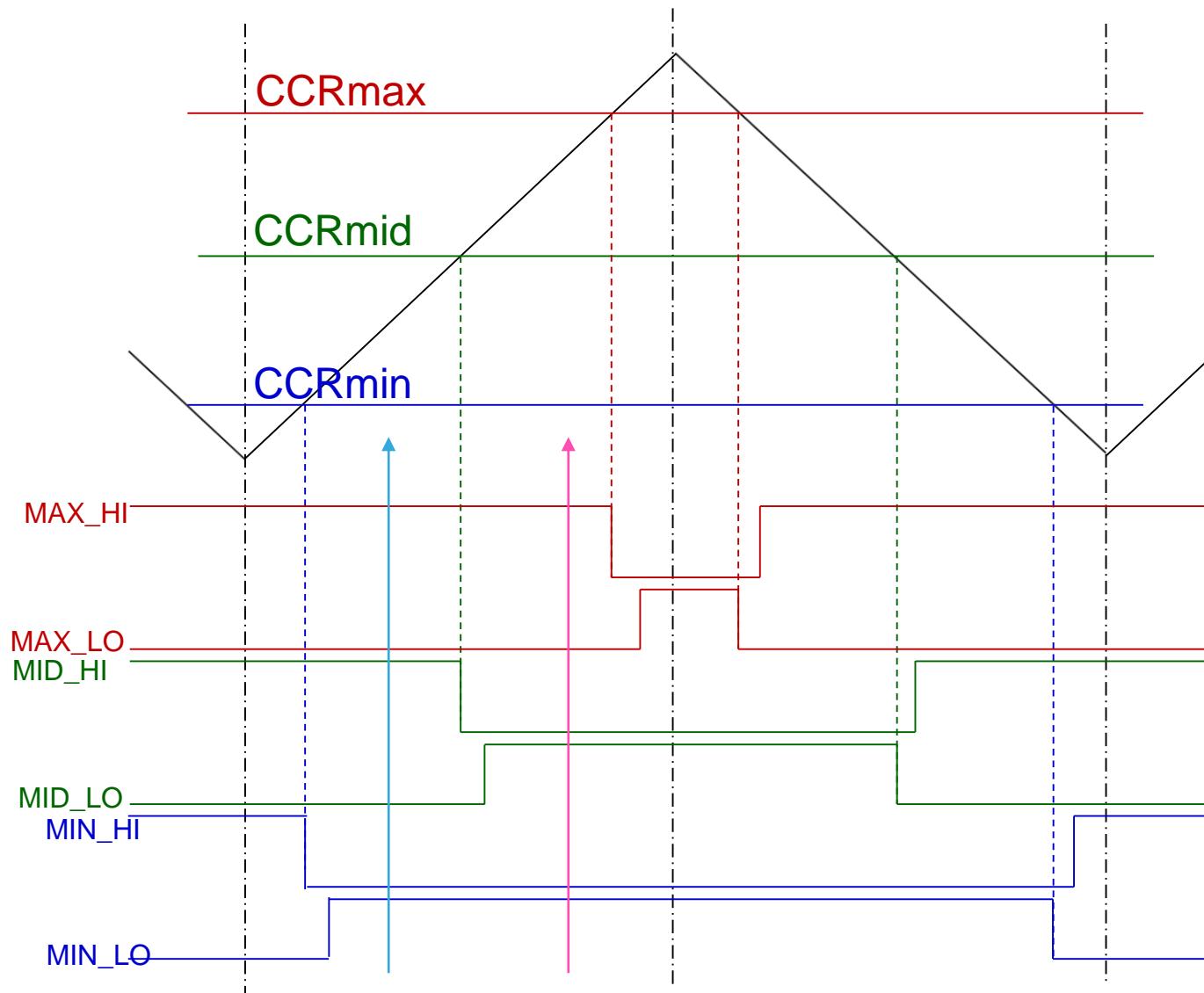


□ 空间电压矢量与单电阻检测到的信号对应的相电流的关系

Vector	$A(X)$	$B(Y)$	$C(Z)$	I_{shunt}
$\overrightarrow{U_0}$	OFF(ON)	OFF(ON)	OFF(ON)	0
$\overrightarrow{U_1}$	ON(OFF)	OFF(ON)	OFF(ON)	i_A
$\overrightarrow{U_2}$	ON(OFF)	ON(OFF)	OFF(ON)	$-i_C$
$\overrightarrow{U_3}$	OFF(ON)	ON(OFF)	OFF(ON)	i_B
$\overrightarrow{U_4}$	OFF(ON)	ON(OFF)	ON(OFF)	$-i_A$
$\overrightarrow{U_5}$	OFF(ON)	OFF(ON)	ON(OFF)	i_C
$\overrightarrow{U_6}$	ON(OFF)	OFF(ON)	ON(OFF)	$-i_B$
$\overrightarrow{U_7}$	ON(OFF)	ON(OFF)	ON(OFF)	0

电流采样 — 单电阻(3/8)

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$$T_p = T_{dead} + T_{on} + T_{ADC\ s/h} + \text{Max}(T_{ring}, T_{ADCtrigger\ delay})$$

- T_p – 电流采样最小脉宽时间
 T_{dead} – 死区时间
 T_{on} – ADC启动时间
 T_{ring} – 振铃时间
 $T_{ADCtrigger\ delay}$ – ADC触发延迟时间
 $T_{ADCs/h}$ – ADC采样时间

ADC采样触发点:

第一点:

当 $T(CCRmid - CCRmin) > T_{dead} + T_{ring} + T_{ADC\ s/h}$
采样点为 $\frac{T(CCRmid + CCRmin) + T_{dead}}{2}$

否则为 $TCCRmid - T_{ADCtrigger\ delay} - T_{ADC\ s/h}$

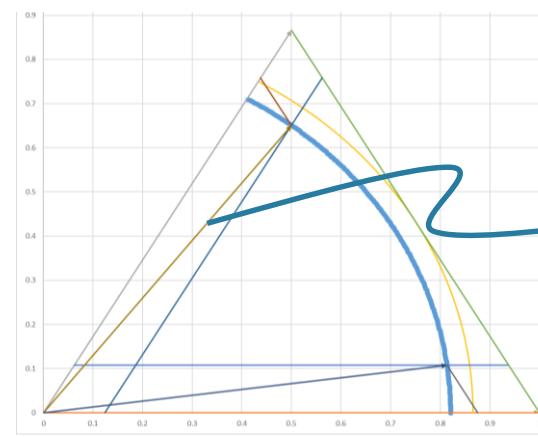
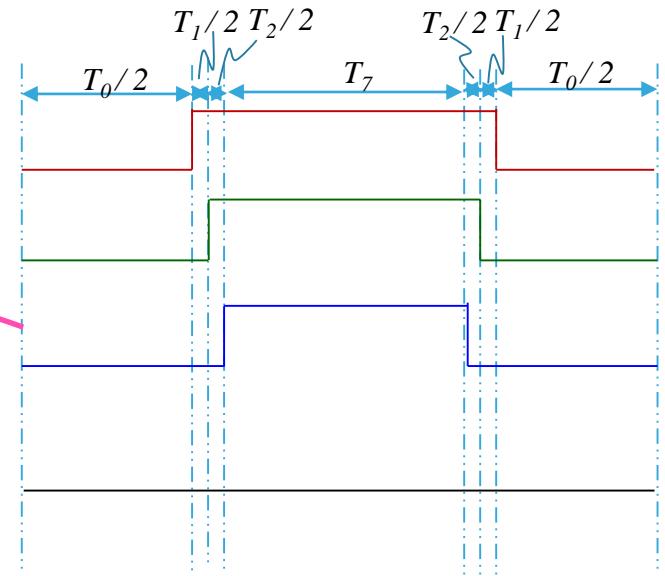
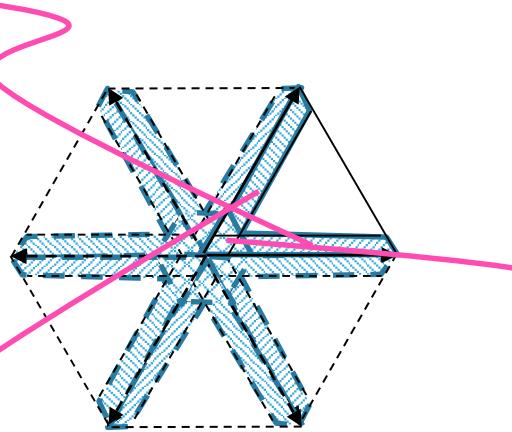
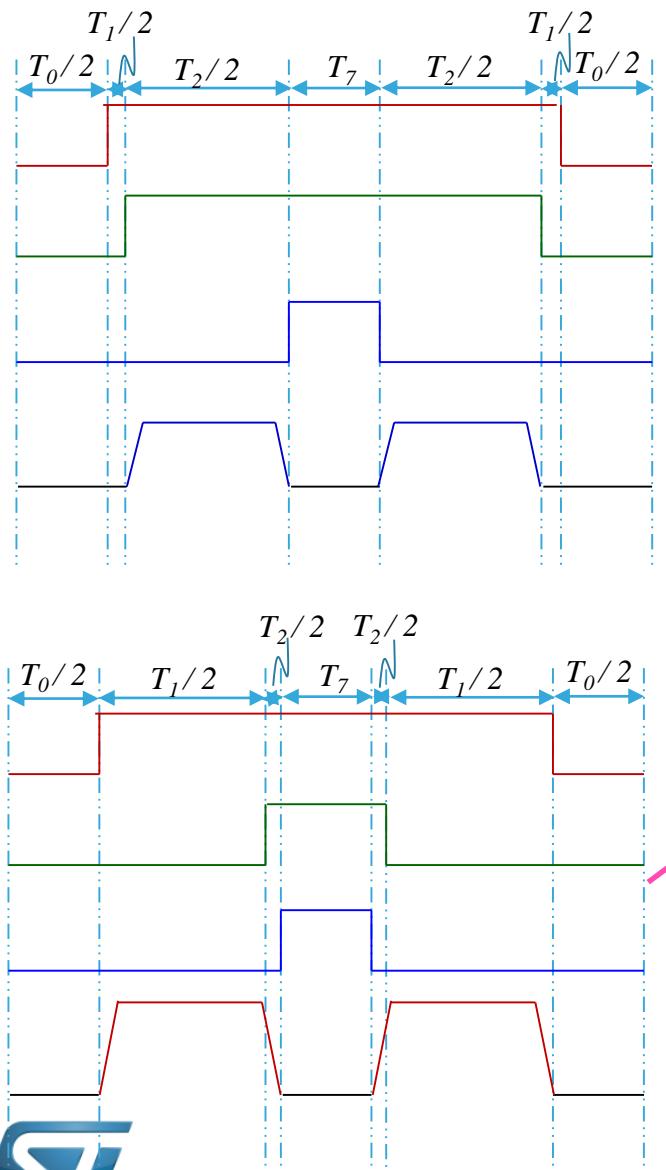
第二点:

当 $T(CCRmax - CCRmid) > T_{dead} + T_{ring} + T_{ADC\ s/h}$
采样点为 $\frac{T(CCRmax + CCRmid) + T_{dead}}{2}$

否则为 $TCCRmax - T_{ADCtrigger\ delay} - T_{ADC\ s/h}$

电流采样 — 单电阻(4/8)

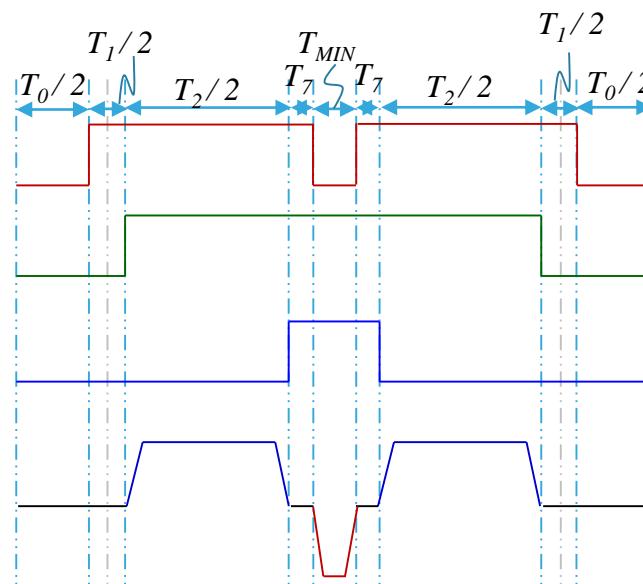
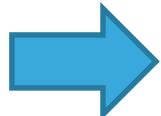
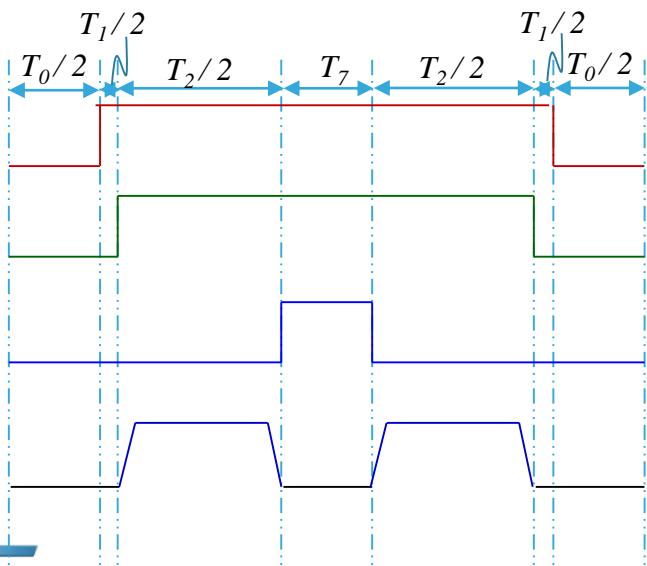
15



MMI=Max Modulation Index

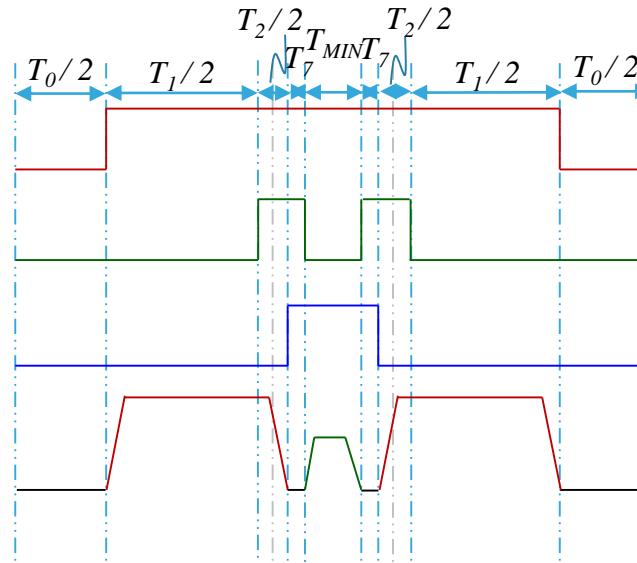
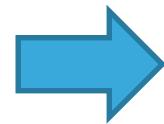
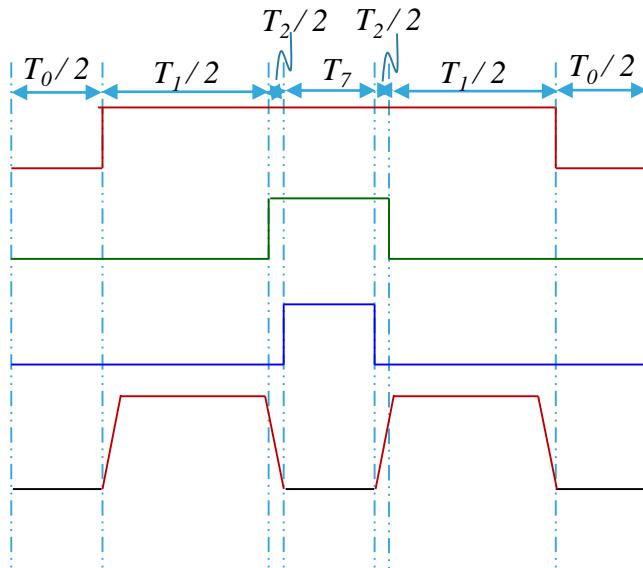
ST 专利
US20090284194 A1

ST 专利 (Pat. Pub. No.: US20090284194 A1) 解决单电阻无法采样问题



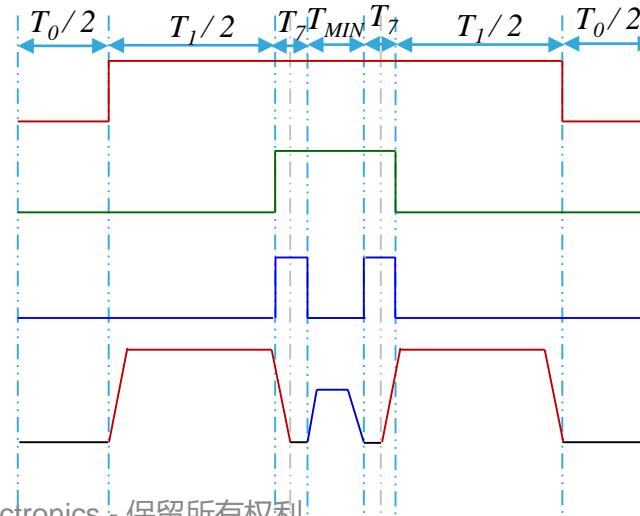
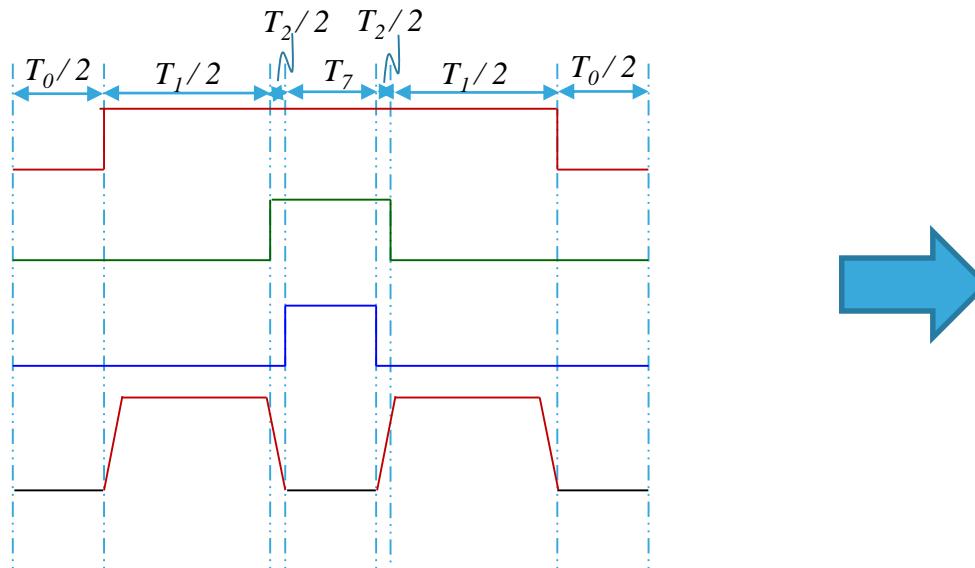
ST 专利
US20090284194 A1

ST 专利 (Pat. Pub. No.: US20090284194 A1) 解决单电阻无法采样问题



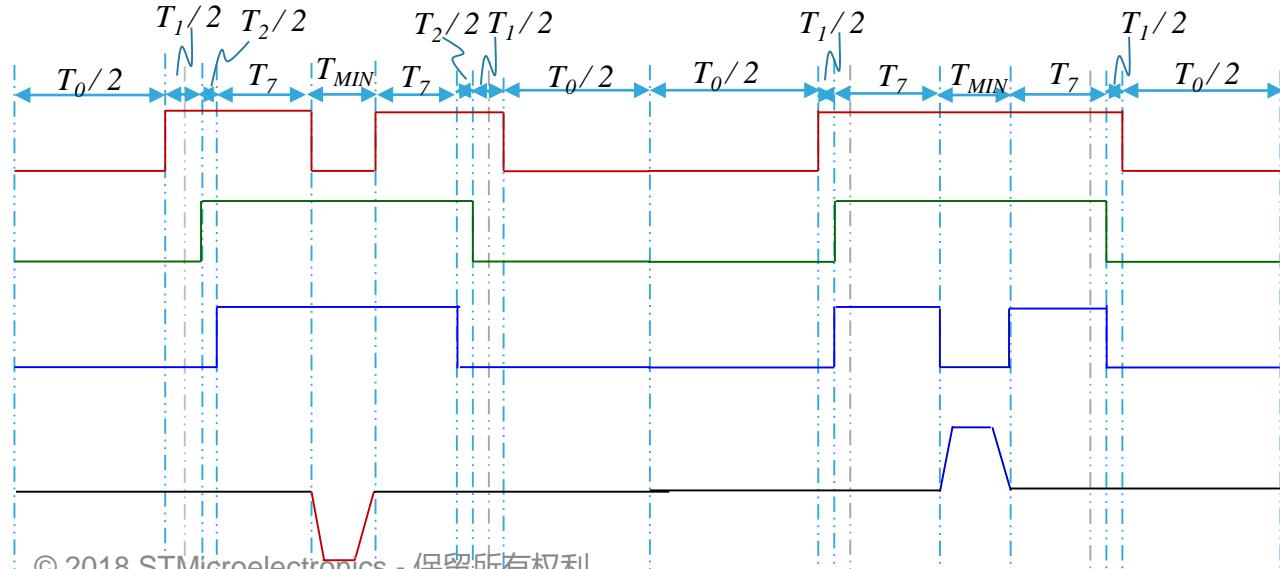
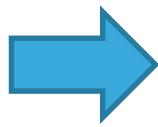
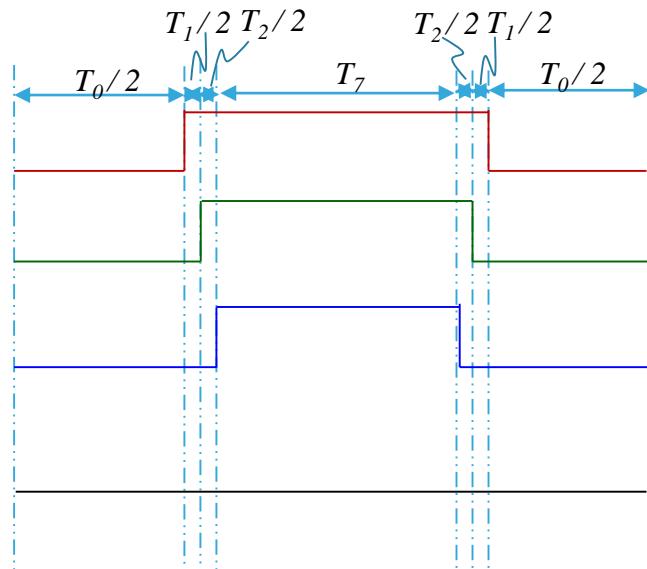
ST 专利
US20090284194 A1

ST 专利 (Pat. Pub. No.: US20090284194 A1) 解决单电阻无法采样问题



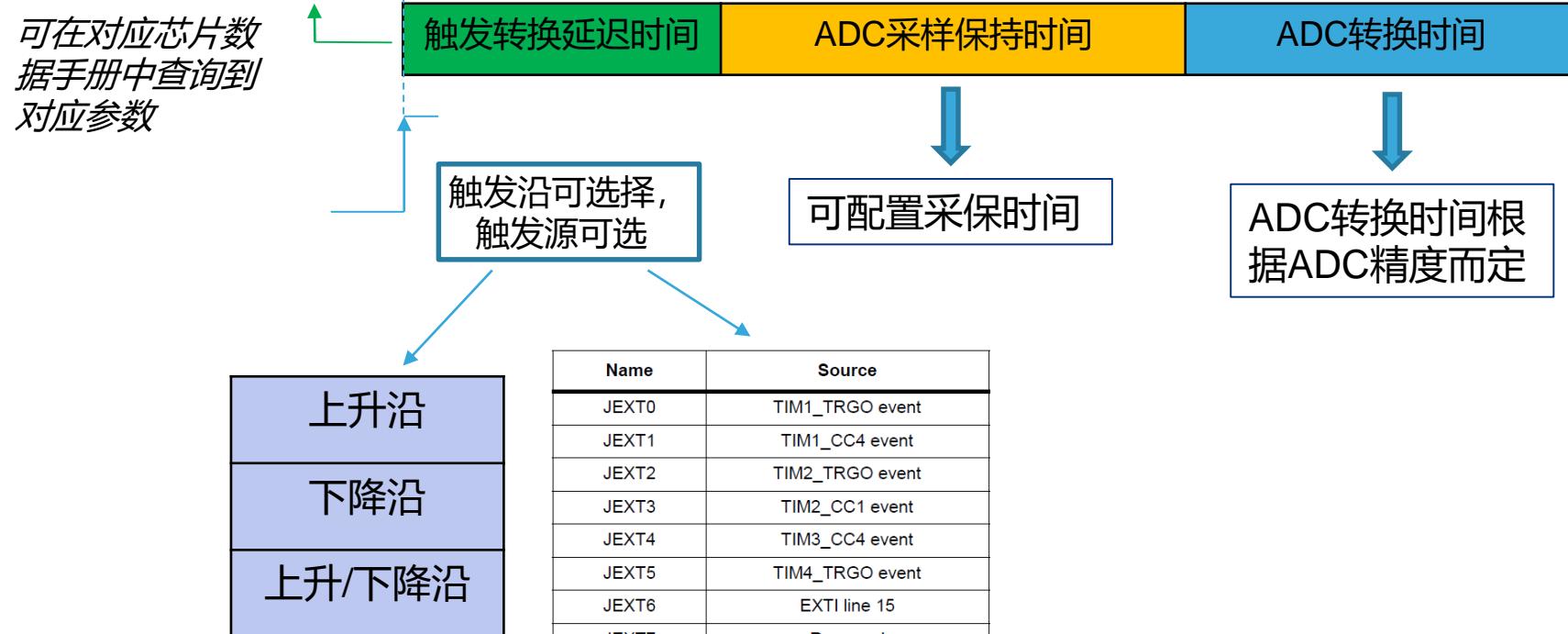
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US20090284194 A1

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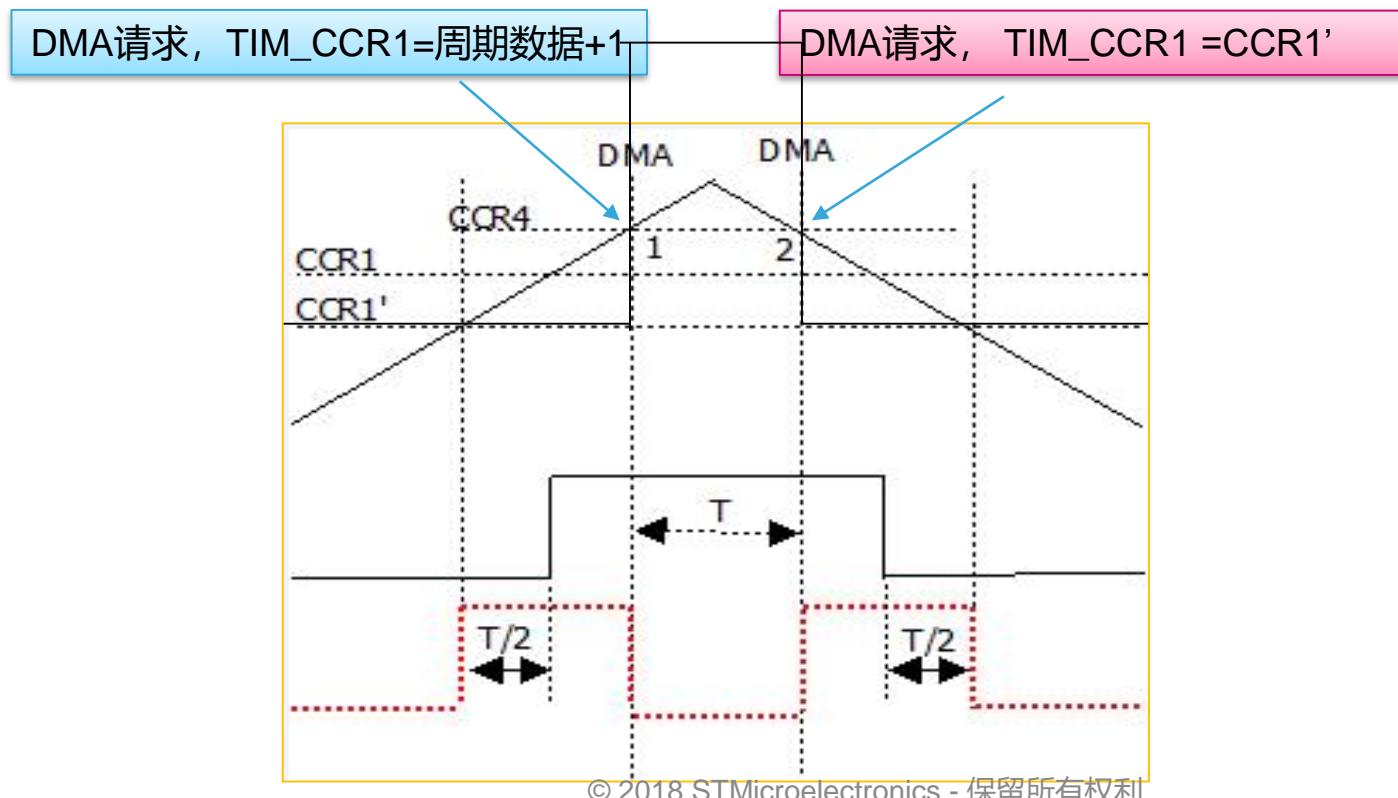
ADC采样机制说明

$t_{latr}^{(1)}$	Trigger conversion latency Regular and injected channels without conversion abort	CKMODE = 00	1.5	2	2.5	$1/f_{ADC}$
		CKMODE = 01	-	-	2	$1/f_{ADC}$
		CKMODE = 10	-	-	2.25	$1/f_{ADC}$
		CKMODE = 11	-	-	2.125	$1/f_{ADC}$
$t_{latrinj}^{(1)}$	Trigger conversion latency Injected channels aborting a regular conversion	CKMODE = 00	2.5	3	3.5	$1/f_{ADC}$
		CKMODE = 01	-	-	3	$1/f_{ADC}$
		CKMODE = 10	-	-	3.25	$1/f_{ADC}$
		CKMODE = 11	-	-	3.125	$1/f_{ADC}$

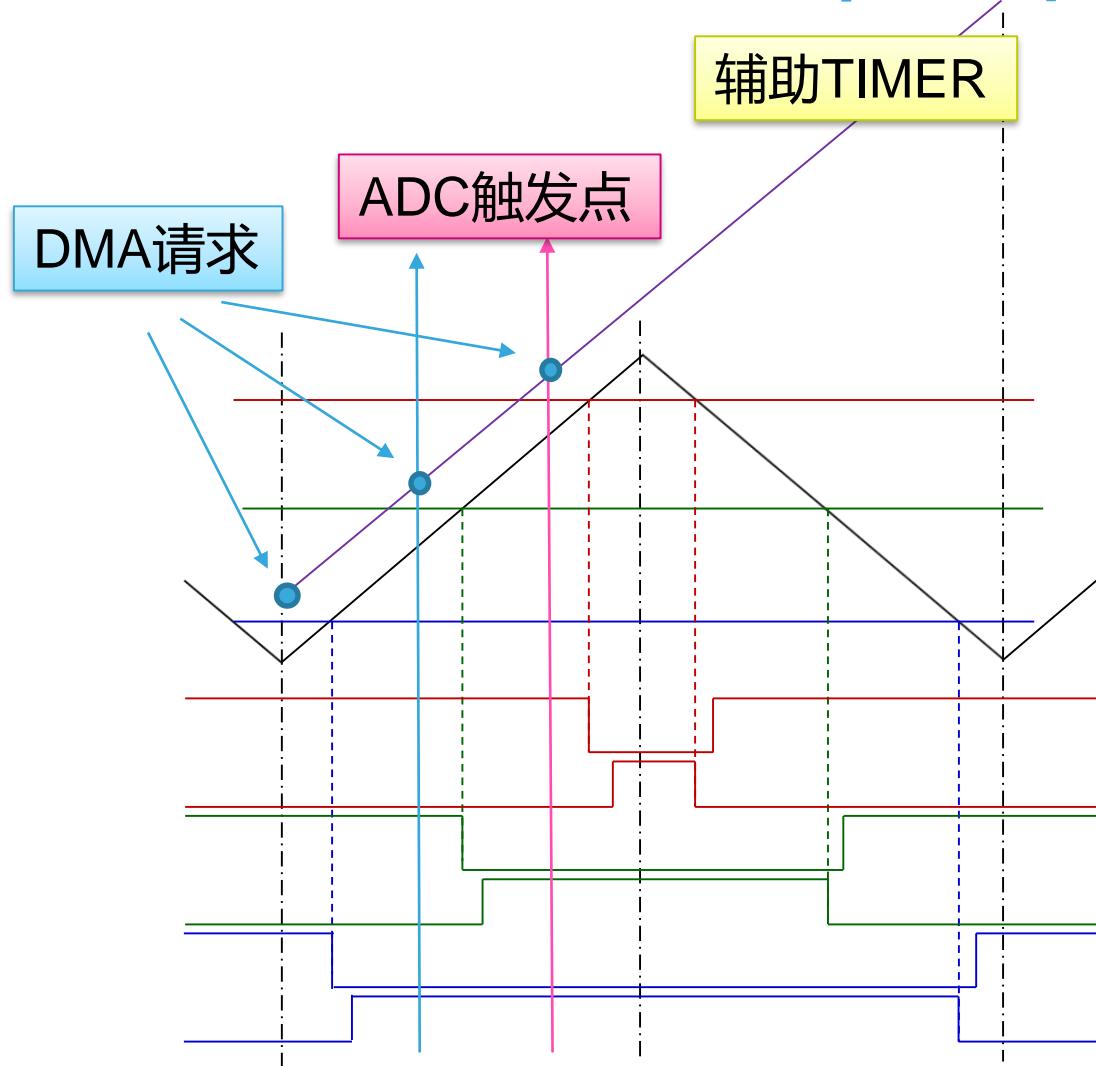


波形变形机制说明

- $CCR4 = Tc/2 - minPulse/2$ 在CCR4 比较值1部分产生DMA事件; Timer1的preload为禁止状态; $CCR1 = Tc/2 + delta$
- 在CCR4 比较值2 部分产生DMA事件; $CCR1' = CCR1 - minPulse/2$



单电阻ADC触发机制说明



- 辅助TIMER (比如TIM15) 与电机TIMER (如TIM1) 做同步动作，同频输出；
- 配置DMA重载辅助TIMER的CCR寄存器；
- 辅助TIMER的TRGO输出用于硬件触发ADC采样；
- ADC配置为非连续模式，序列采样中断，采样两次后进入FOC处理中断中；

在STM32F3xx系列中电机TIMER有自带的机制可以灵活配置

ST MC SDK5.x 单电阻采样固件

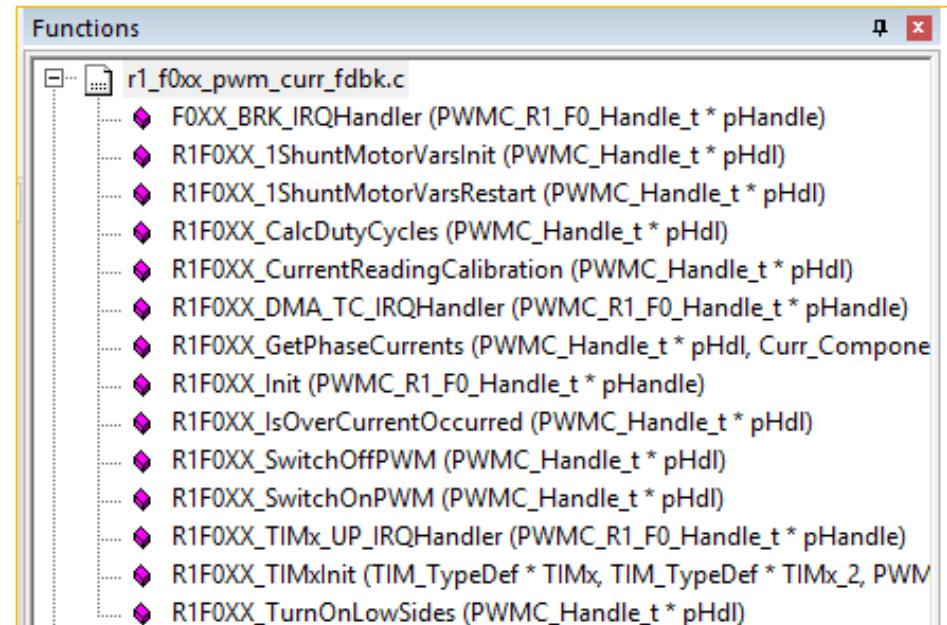
23

➤ 针对STM32系列芯片都有各自的文件：

- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F0xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F1xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F3xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F4xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\F7xx\Src
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\L4xx\Src

➤ 文件名称

- ✓ r1_yxx_pwm_curr_fdbk.c
- ✓ y=f0, f1, f3, f4, f7, l4

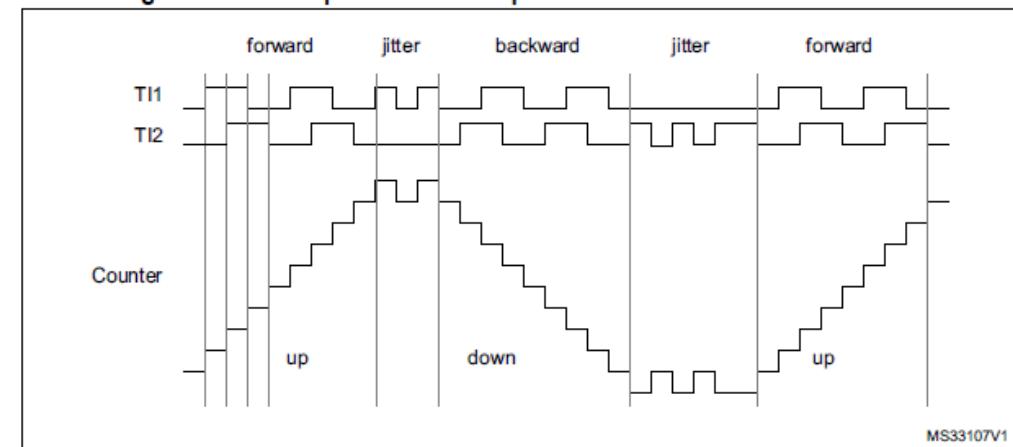
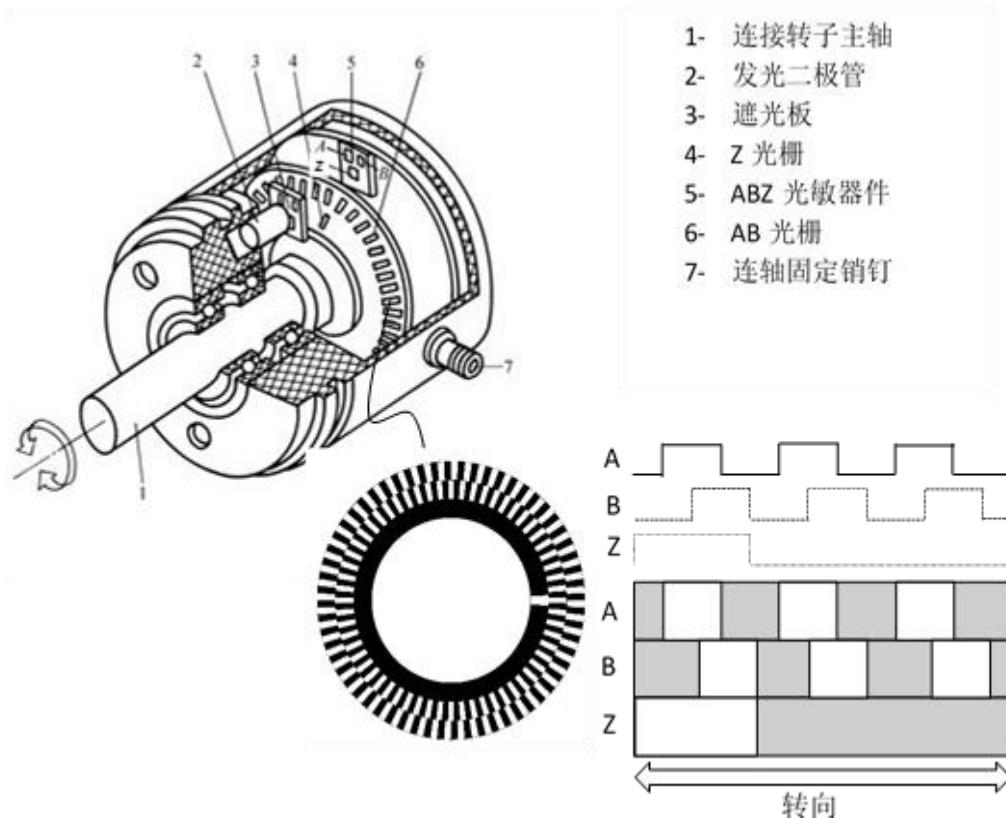


转子位置、速度信息的获取



- 相电流的检测与重构
 - ICS
 - 三电阻
 - 单电阻
- 转子位置、速度信息的获取
 - 有位置传感器
 - 无位置速度传感器

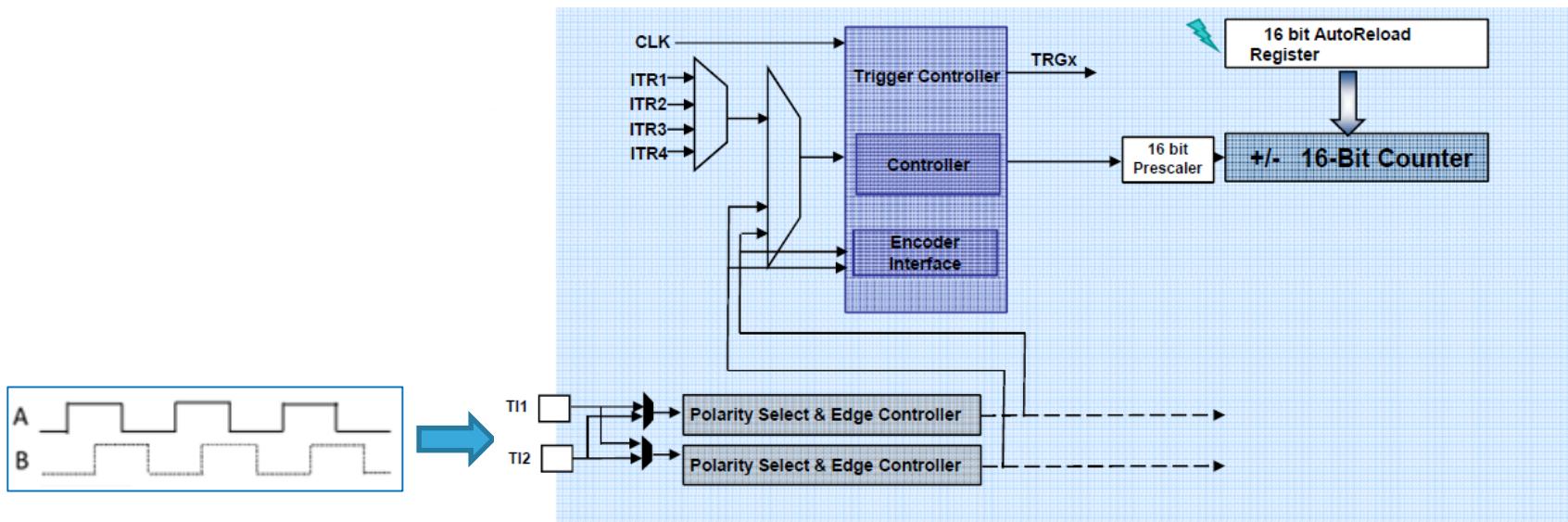
位置速度检测 — Encoder



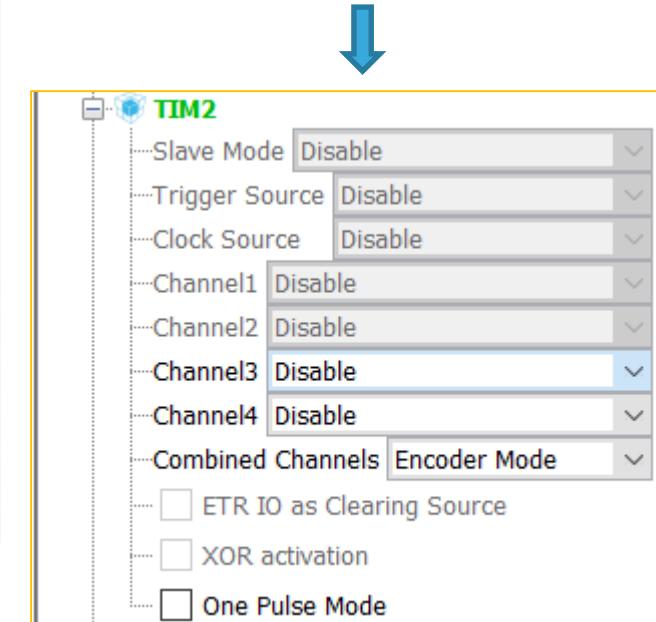
- 使用增量编码器时，在第一次电机启动，任意保护停止或者MCU复位后都要进行预定位操作。
- Z信号（一圈一个）可以使用外部中断或者外部Timer捕捉模式，代表编码器的0度位置，可以用于校准角度位置，可以使用DMA模式对编码器模块赋值；

STM32硬件Encoder接口

- 在全系列STM32中都有硬件增量编码器Encoder接口
- 每个正交沿都可有加/减计数



CubeMx中的配置

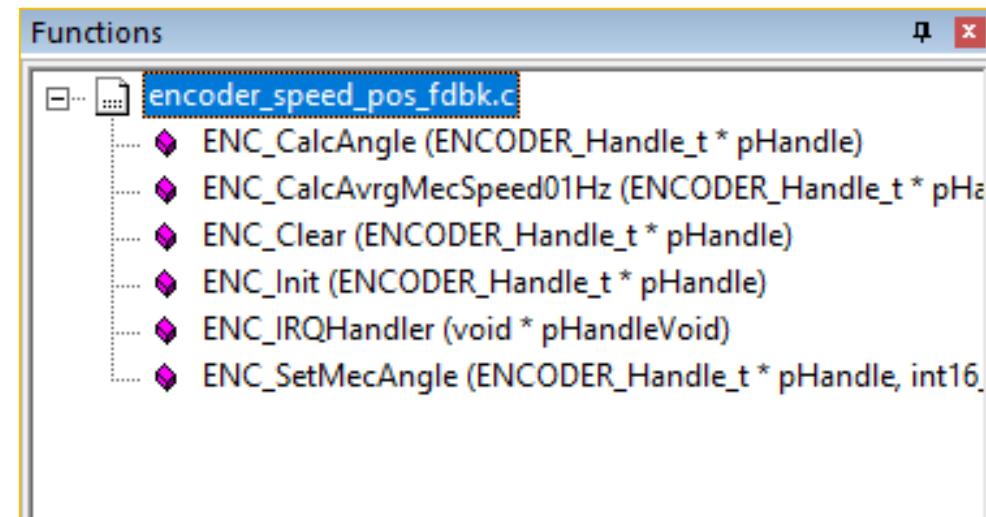


➤ 具体文件夹如下：

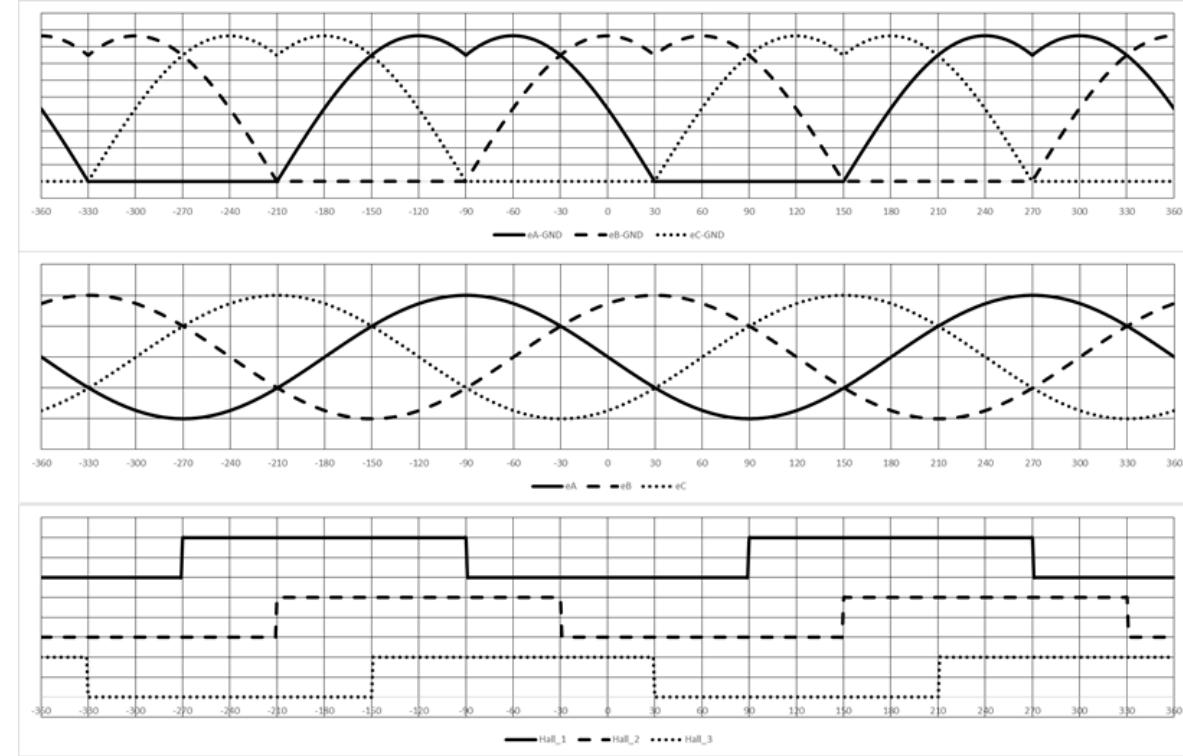
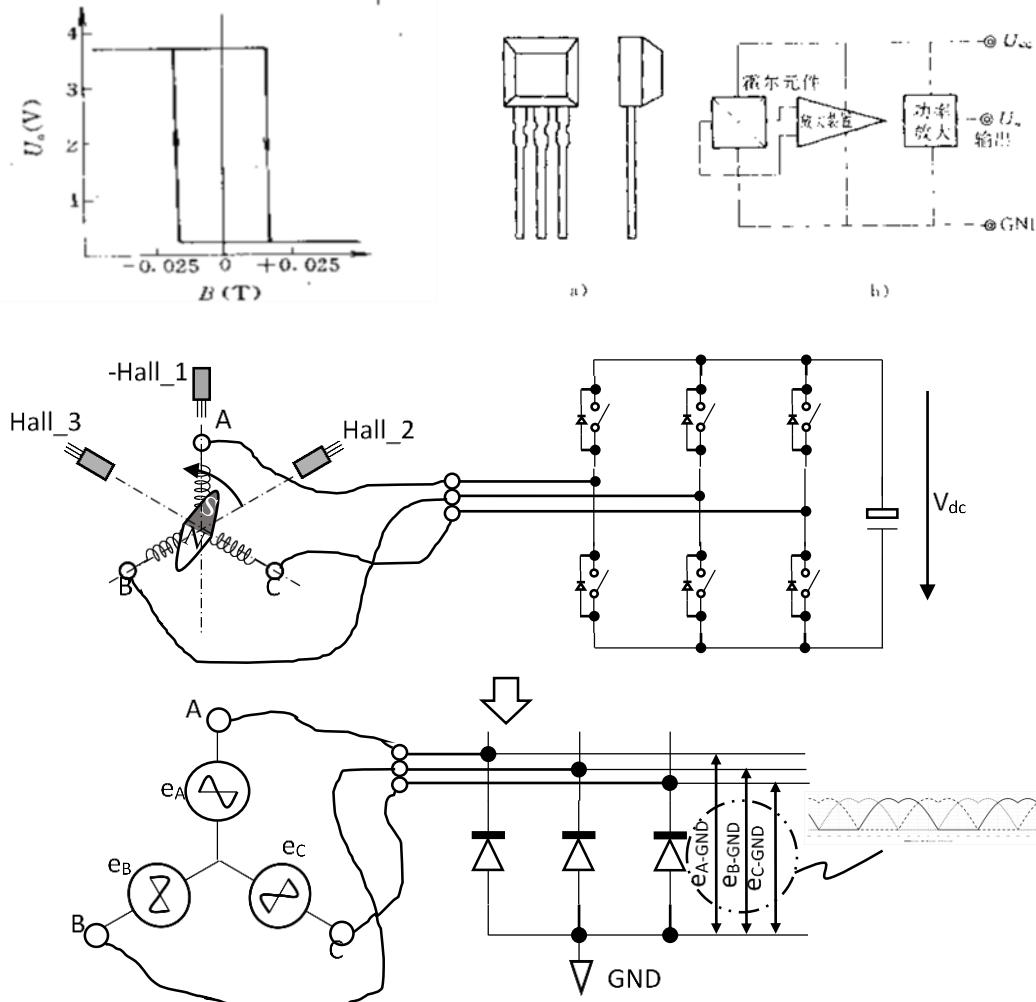
- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\Any\Src

➤ 文件名称

- ✓ encoder_speed_pos_fdbk.c



位置速度检测 — Hall传感器

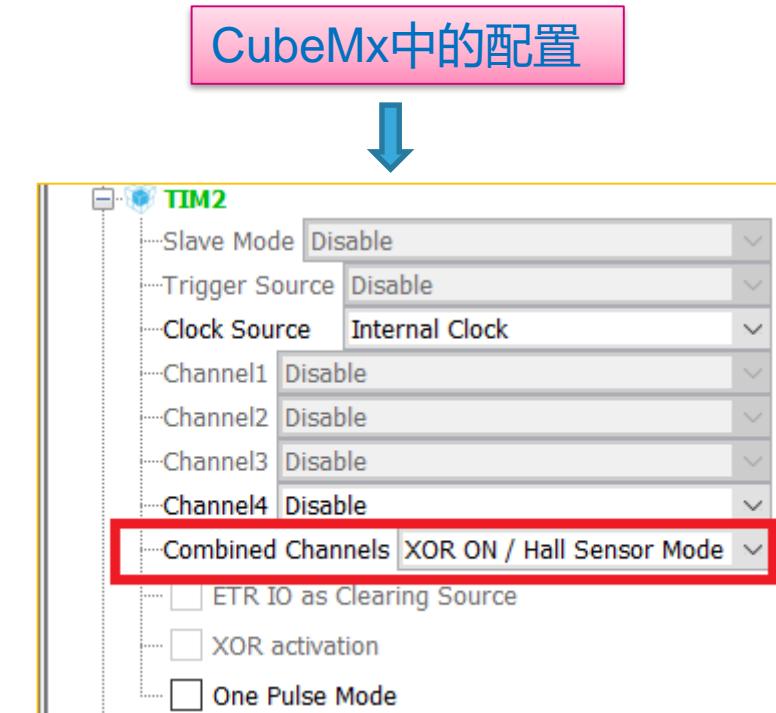
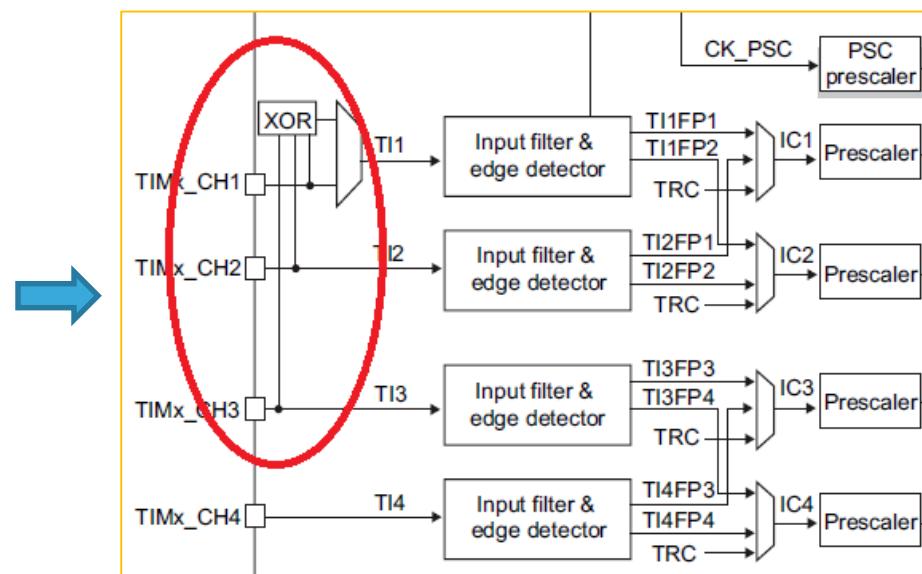
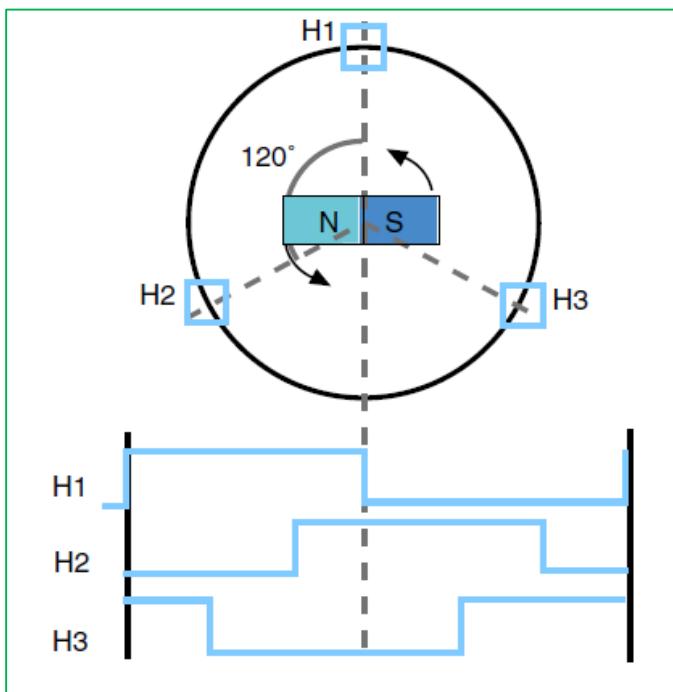


对于60度的Hall信号，可以任意调换三个信号中的任意一个即可得到和120度的处理相似，我们可以很方便使用软件处理。

STM32硬件Hall接口

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- 在全系列STM32中都有硬件Hall接口(XOR输入)
- 可以每个Hall跳变沿都产生中断

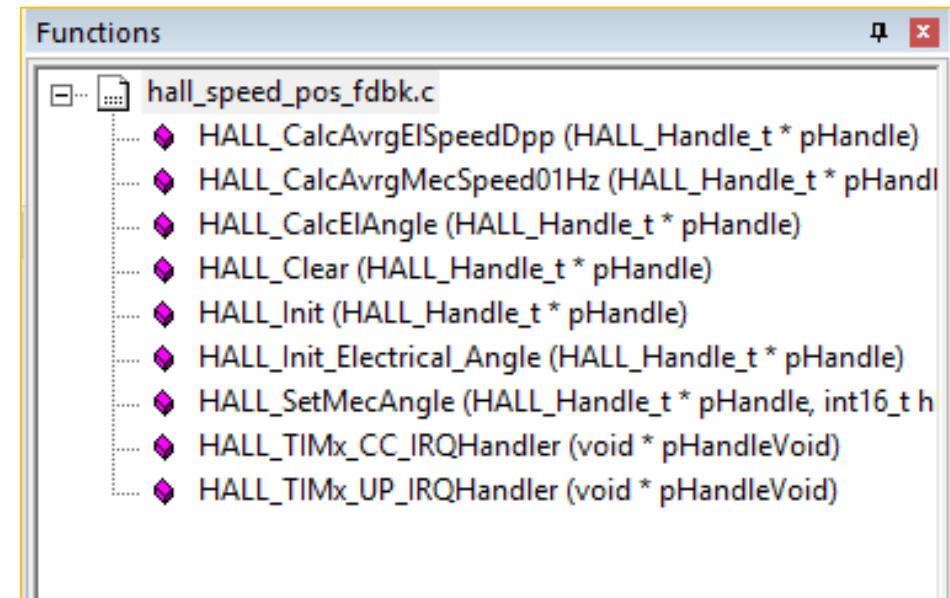


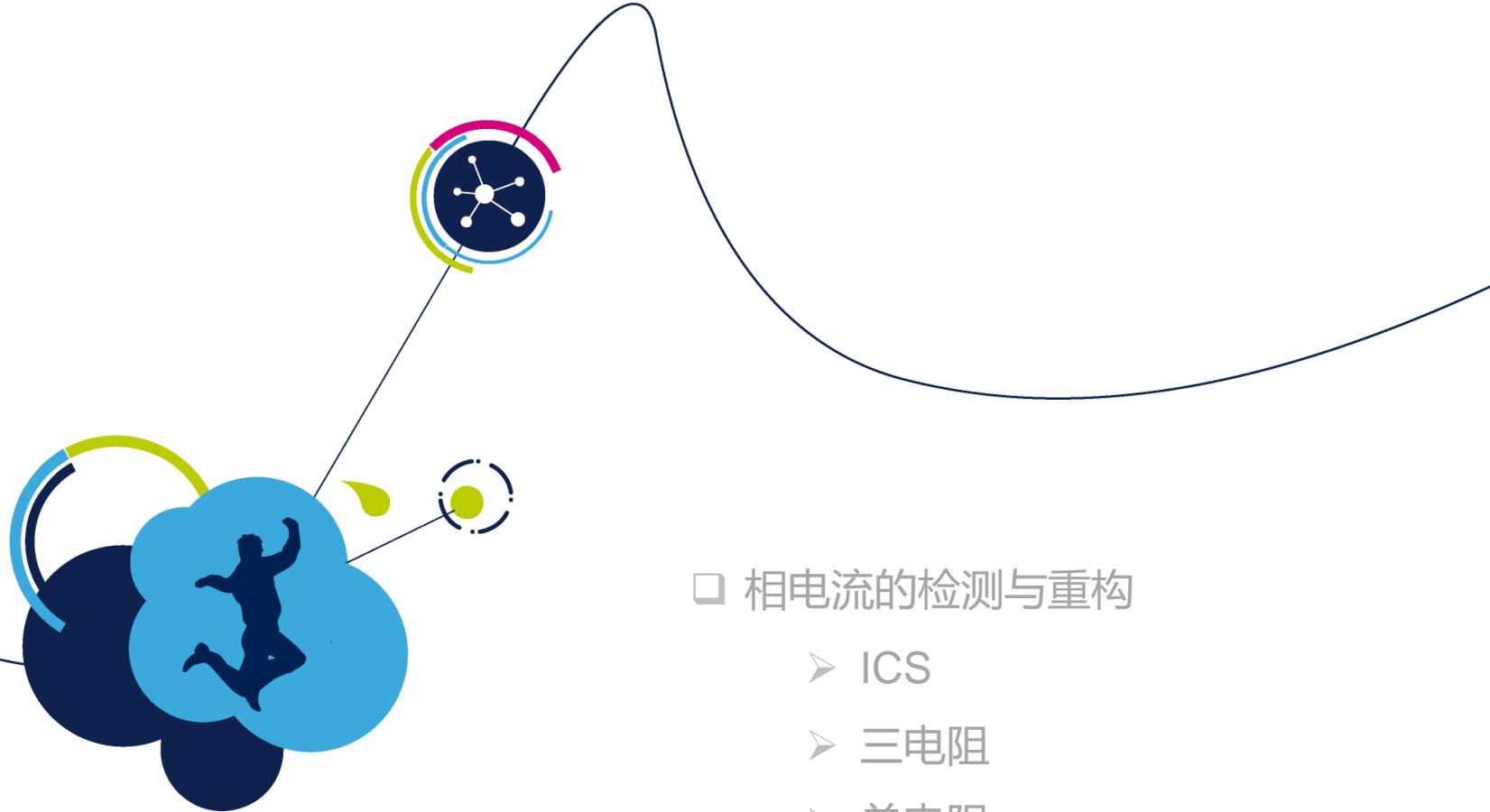
➤ 具体文件夹如下：

- ✓ xxx\MCSDK_v5.2.0\MotorControl\MCSDK\MCLib\Any\Src

➤ 文件名称

- ✓ hall_speed_pos_fdbk.c



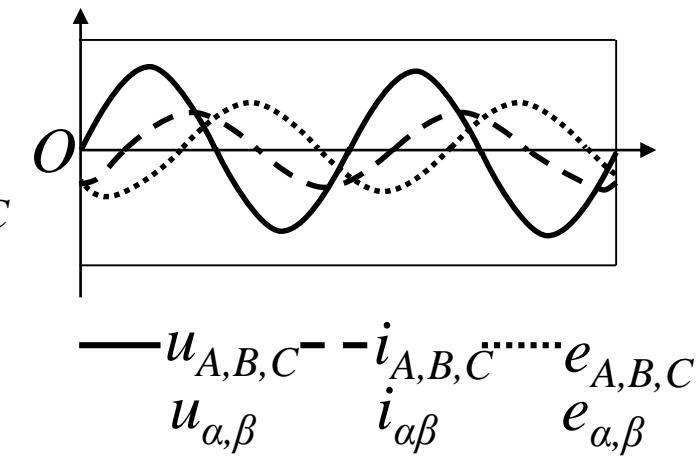
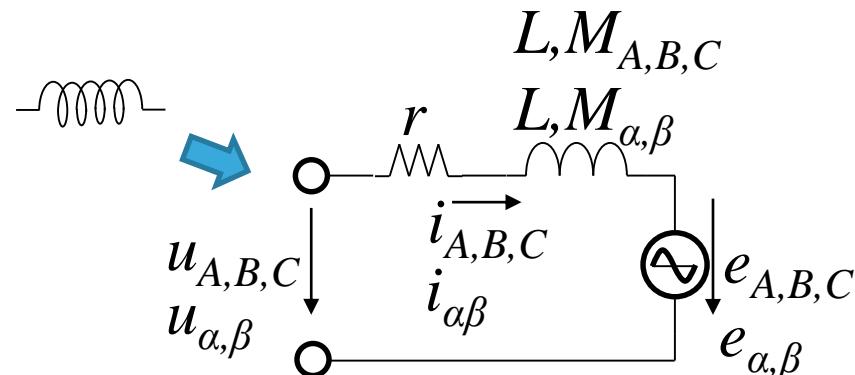
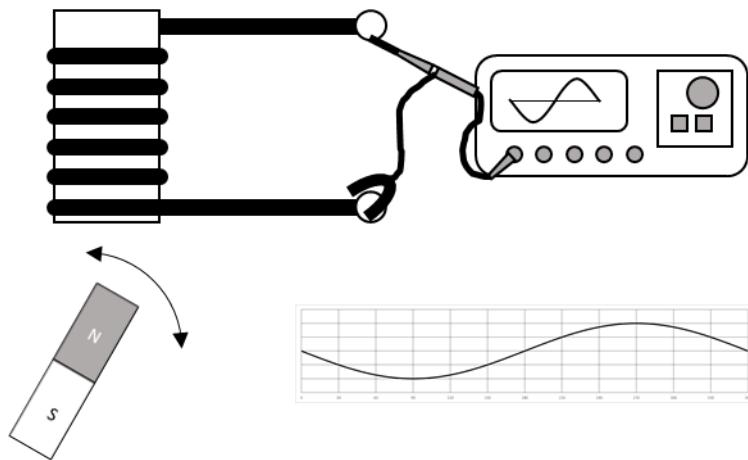


转子位置、速度信息的获取

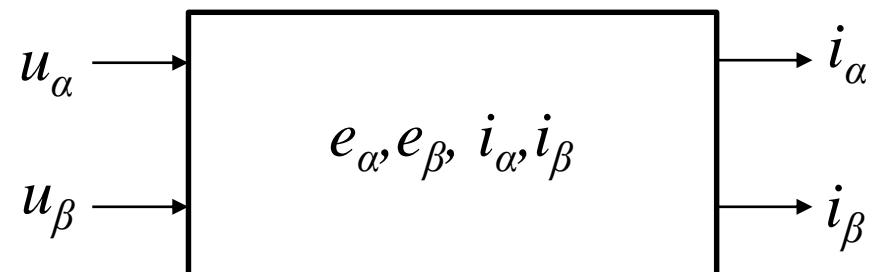
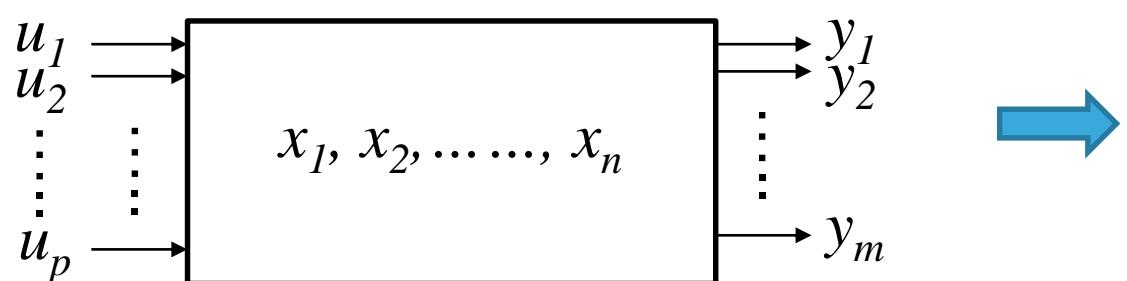
- 相电流的检测与重构
 - ICS
 - 三电阻
 - 单电阻
- 转子位置、速度信息的获取
 - 有位置传感器
 - 无位置速度传感器

位置速度检测 — 观测器(1/13)

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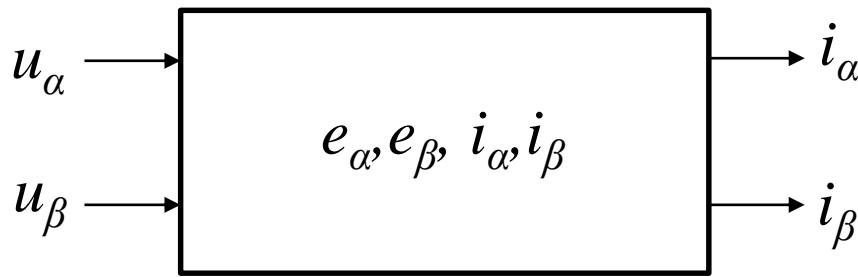
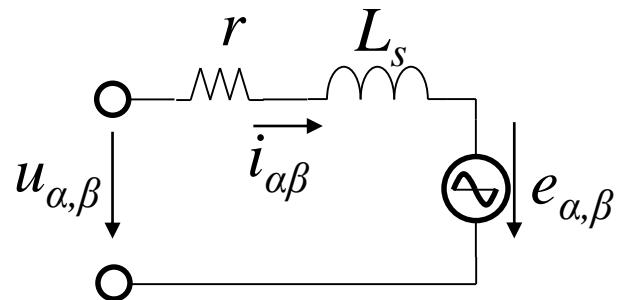


$$u \rightarrow i (\tau_e) \rightarrow \omega_r, \omega_e = p \cdot \omega_r \rightarrow e$$



位置速度检测 — 观测器(2/13)

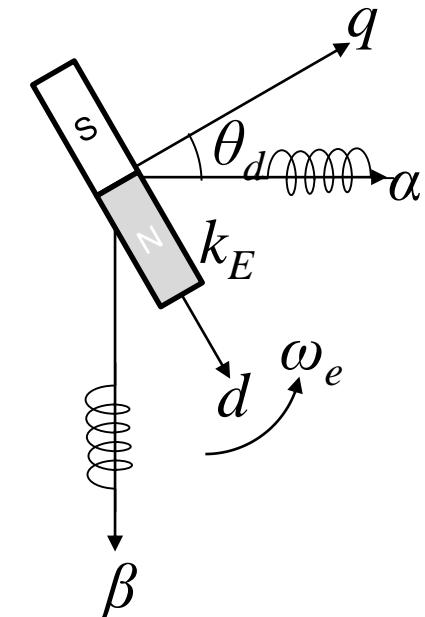
33



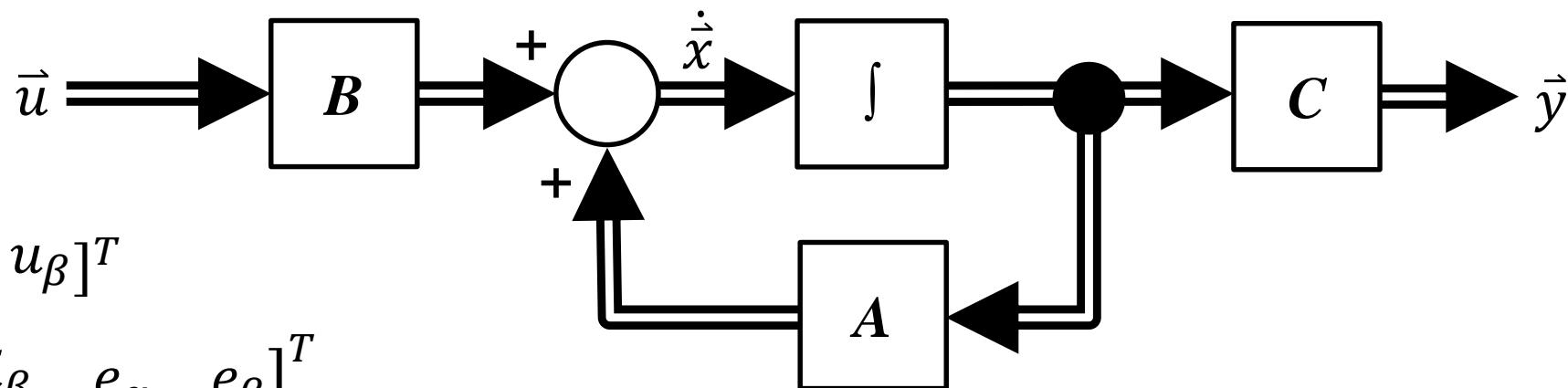
$$\begin{cases} e_\alpha = k_E \omega_e \cos(\omega_e t) \\ e_\beta = -k_E \omega_e \sin(\omega_e t) \end{cases}$$

A linear model

$$\begin{cases} \frac{di_\alpha}{dt} = -\frac{r}{L_s} i_\alpha - \frac{e_\alpha}{L_s} + \frac{u_\alpha}{L_s} \\ \frac{di_\beta}{dt} = -\frac{r}{L_s} i_\beta - \frac{e_\beta}{L_s} + \frac{u_\beta}{L_s} \\ \frac{de_\alpha}{dt} = \omega_e e_\beta \\ \frac{de_\beta}{dt} = -\omega_e e_\alpha \end{cases}$$



位置速度检测 — 观测器(3/13)



$$\vec{u} = [u_\alpha \ u_\beta]^T$$

$$\vec{x} = [i_\alpha \ i_\beta \ e_\alpha \ e_\beta]^T$$

$$\dot{\vec{x}} = \left[\frac{di_\alpha}{dt} \ \frac{di_\beta}{dt} \ \frac{de_\alpha}{dt} \ \frac{de_\beta}{dt} \right]^T$$

$$\vec{y} = [i_\alpha \ i_\beta]^T$$

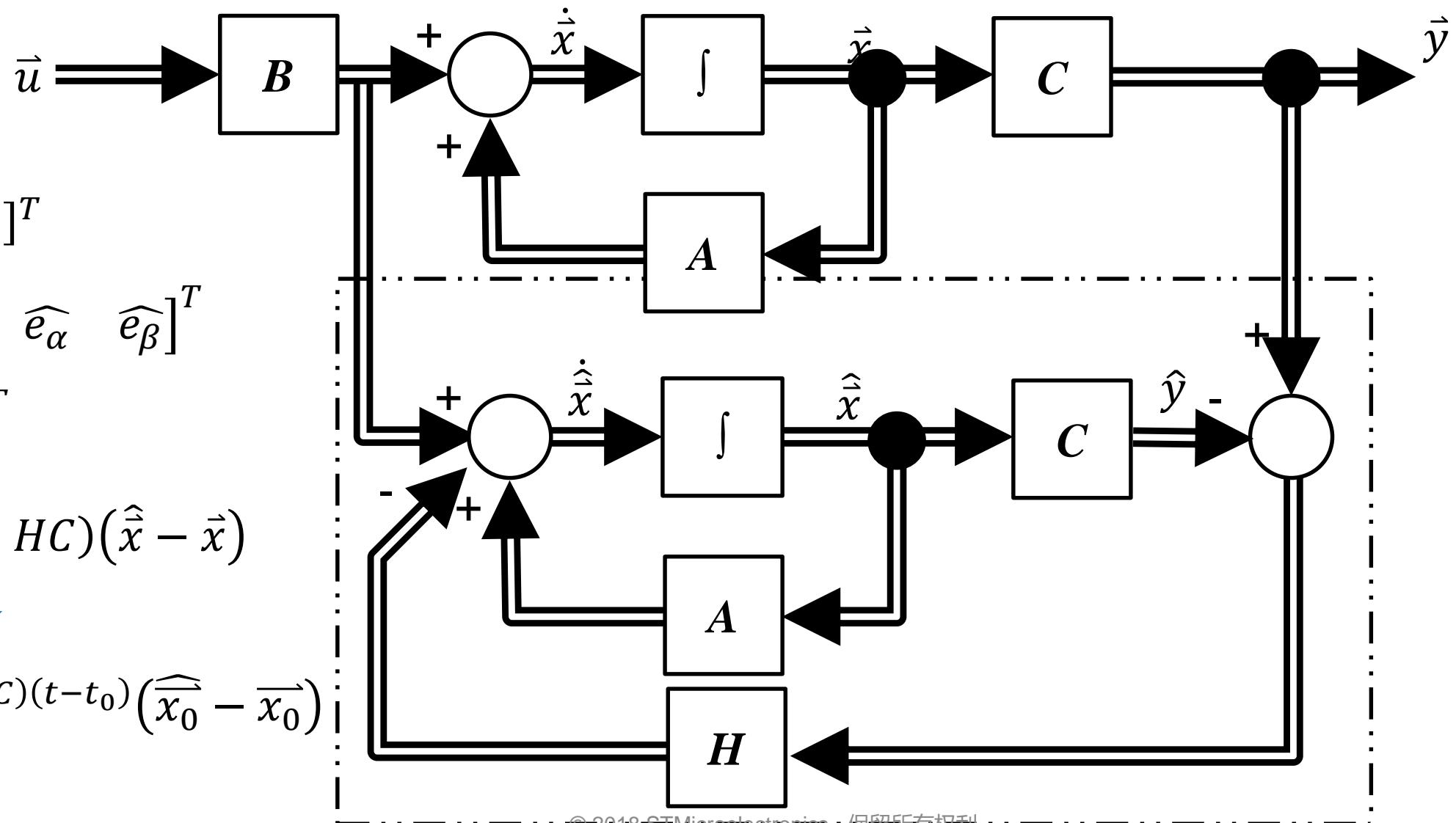
$$\begin{cases} \dot{\vec{x}} = A\vec{x} + B\vec{u} \\ \vec{y} = C\vec{x} \end{cases}$$

$$A = \begin{bmatrix} -\frac{r}{L_s} & 0 & -\frac{1}{L_s} & 0 \\ 0 & -\frac{r}{L_s} & 0 & -\frac{1}{L_s} \\ 0 & 0 & 0 & \omega_e \\ 0 & 0 & -\omega_e & 0 \end{bmatrix} \quad B = \begin{bmatrix} -\frac{1}{L_s} & 0 \\ 0 & -\frac{1}{L_s} \\ 0 & 0 \\ 0 & 0 \end{bmatrix}$$

$$C = \begin{bmatrix} 1 & 0 & 0 & 0 \\ 0 & 1 & 0 & 0 \end{bmatrix}$$

位置速度检测 — 观测器(4/13)

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位置速度检测 — 观测器(5/13)

$$\begin{cases} \dot{\vec{x}} = A\vec{x} + B\vec{u} \\ \vec{y} = C\vec{x} \end{cases} \xrightarrow{\text{离散化}} \begin{cases} \dot{\vec{x}} = \frac{d\vec{x}}{dt} \approx \frac{\vec{x}[k] - \vec{x}[k-1]}{T_s} \\ \vec{x}[k] = \vec{x}[k-1] + \frac{\vec{x}[k] - \vec{x}[k-1]}{T_s} = A\vec{x}[k-1] + B\vec{u}[k-1] \\ \vec{y}[k] = C\vec{x}[k] \end{cases}$$

$$\begin{cases} i_\alpha[k] = \left(1 - \frac{rT_s}{L_s}\right) i_\alpha[k-1] - \frac{T_s}{L_s} e_\alpha[k-1] + \frac{T_s}{L_s} u_\alpha \\ i_\beta[k] = \left(1 - \frac{rT_s}{L_s}\right) i_\beta[k-1] - \frac{T_s}{L_s} e_\beta[k-1] + \frac{T_s}{L_s} u_\beta \\ e_\alpha[k] = e_\alpha[k-1] + \omega_e e_\beta[k-1] T_s \\ e_\beta[k] = e_\beta[k-1] - \omega_e e_\alpha[k-1] T_s \end{cases}$$

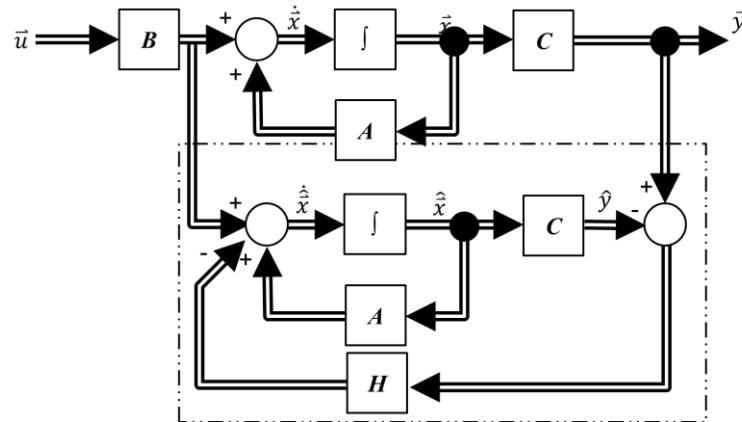
位置速度检测 — 观测器(6/13)

去耦(认为 $\omega_e=0$) 将简化马达模型

$$\begin{cases} i_\alpha[k] = \left(1 - \frac{rT_s}{L_s}\right) i_\alpha[k-1] - \frac{T_s}{L_s} e_\alpha[k-1] + \frac{T_s}{L_s} u_\alpha \\ e_\alpha[k] = e_\alpha[k-1] \end{cases}$$

$$A_{reduced} = \begin{bmatrix} 1 - \frac{rT_s}{L_s} & -\frac{T_s}{L_s} \\ 0 & 1 \end{bmatrix} \xrightarrow{\text{特征值}} |\lambda I - A| = 0 \quad \begin{cases} \lambda_1 = 1 - \frac{rT_s}{L_s} \\ \lambda_2 = 1 \end{cases}$$

位置速度检测 — 观测器(7/13)



$$\dot{\hat{x}} = A\hat{x} + B\bar{u} + H(\hat{y} - \vec{y}) \quad H = \begin{bmatrix} h_1 & 0 \\ 0 & h_1 \\ h_2 & 0 \\ 0 & h_2 \end{bmatrix}$$

$$\left\{ \begin{array}{l} \hat{i}_\alpha[k] = \left(1 - \frac{rT_s}{L_s} + h_1 T_s\right) \hat{i}_\alpha[k-1] - \frac{T_s}{L_s} \hat{e}_\alpha[k-1] + \frac{T_s}{L_s} u_\alpha[k-1] + h_1 T_s (-i_\alpha[k-1]) \\ \hat{i}_\beta[k] = \left(1 - \frac{rT_s}{L_s} + h_1 T_s\right) \hat{i}_\beta[k-1] - \frac{T_s}{L_s} \hat{e}_\beta[k-1] + \frac{T_s}{L_s} u_\beta[k-1] + h_1 T_s (-i_\beta[k-1]) \\ \hat{e}_\alpha[k] = \hat{e}_\alpha[k-1] + T_s \omega_e \hat{e}_\beta[k-1] + h_2 T_s (\hat{i}_\alpha[k-1] - i_\alpha[k-1]) \\ \hat{e}_\beta[k] = \hat{e}_\beta[k-1] - T_s \omega_e \hat{e}_\alpha[k-1] + h_2 T_s (\hat{i}_\beta[k-1] - i_\beta[k-1]) \end{array} \right.$$

位置速度检测 — 观测器(8/13)

去耦(设定 $\omega_e=0$) 简化观测器模型

$$\begin{cases} \hat{i}_\alpha[k] = \left(1 - \frac{rT_s}{L_s} + h_1 T_s\right) \hat{i}_\alpha[k-1] - \frac{T_s}{L_s} \hat{e}_\alpha[k-1] + \frac{T_s}{L_s} u_\alpha[k-1] + h_1 T_s (-i_\alpha[k-1]) \\ \hat{e}_\alpha[k] = \hat{e}_\alpha[k-1] + h_2 T_s (\hat{i}_\alpha[k-1] - i_\alpha[k-1]) \end{cases}$$

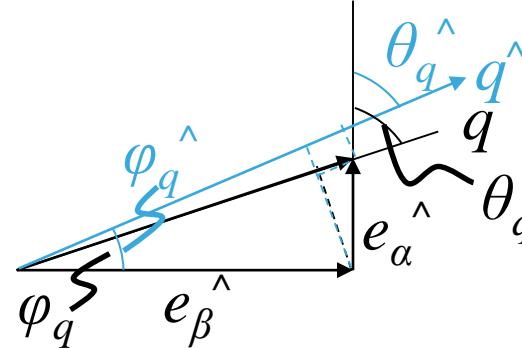
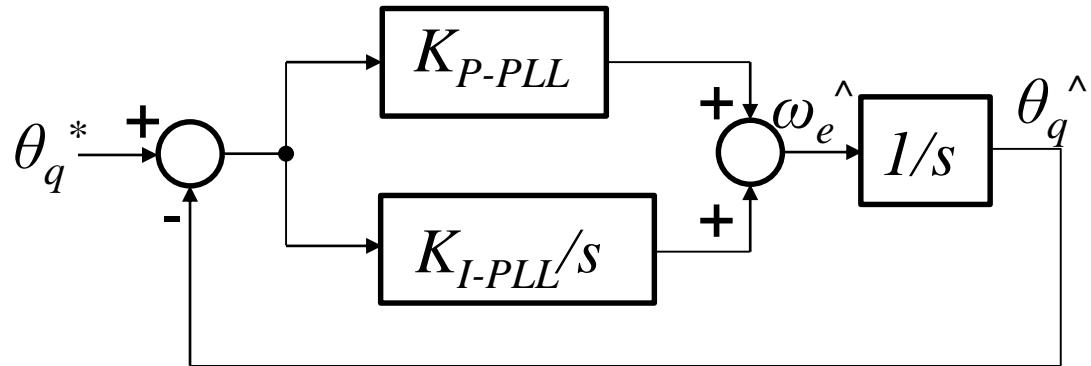
$$A_{reduced-obs} = \begin{bmatrix} 1 - \frac{rT_s}{L_s} + h_1 T_s & -\frac{T_s}{L_s} \\ h_2 T_s & 1 \end{bmatrix} \quad \begin{array}{l} \lambda_{1-obs} = \frac{\lambda_1}{k} \\ \lambda_{2-obs} = \frac{\lambda_2}{k} \end{array} \quad k > 1$$

$| \lambda I - A_{reduced-obs} | = (\lambda - \lambda_{1-obs})(\lambda - \lambda_{2-obs})$

$$\begin{cases} h_1 = \frac{\lambda_{1-obs} + \lambda_{2-obs} - 2}{T_s} + \frac{r}{L_s} \\ h_2 = \frac{L_s(1 - \lambda_{1-obs} - \lambda_{2-obs} + \lambda_{1-obs}\lambda_{2-obs})}{{T_s}^2} \end{cases}$$

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位置速度检测 — 观测器(9/13)



$$G(s) = \frac{Ts + 1}{s^2 + 2\zeta\omega_n s + \omega_n^2}$$

$$e = k_E \omega_e = \sqrt{e_\alpha^2 + e_\beta^2}$$

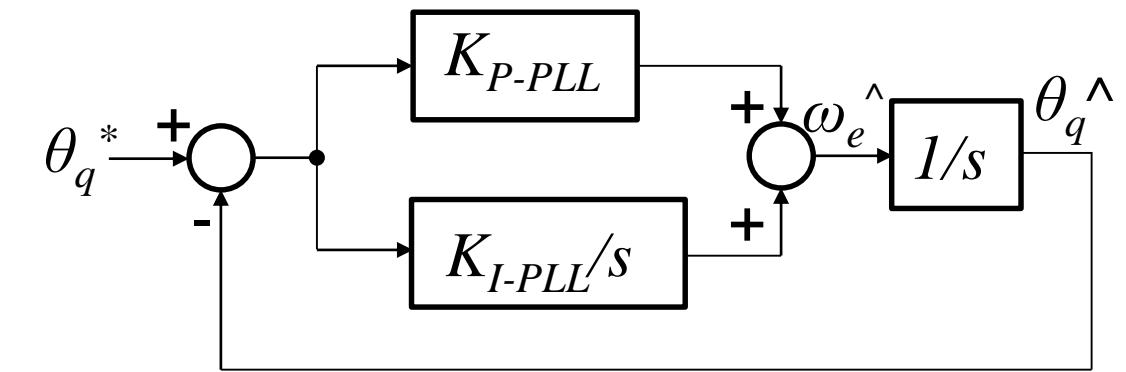
$$\begin{cases} K_{P-PLL} = \omega_n \\ K_{I-PLL} = \frac{K_{P-PLL} \omega_n}{(2\zeta)^2} \end{cases}$$

$$e \cdot \sin(\theta_q^ - \theta_q) = e_\beta \cos(\theta_q^) - e_\alpha \sin(\theta_q^)$$

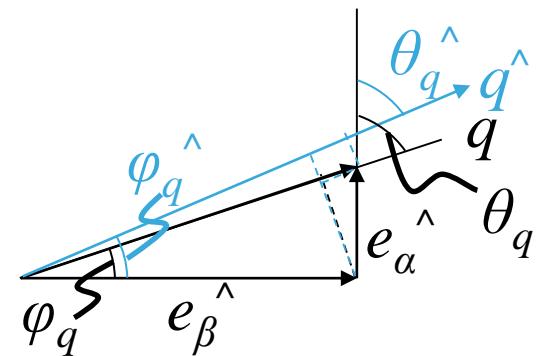
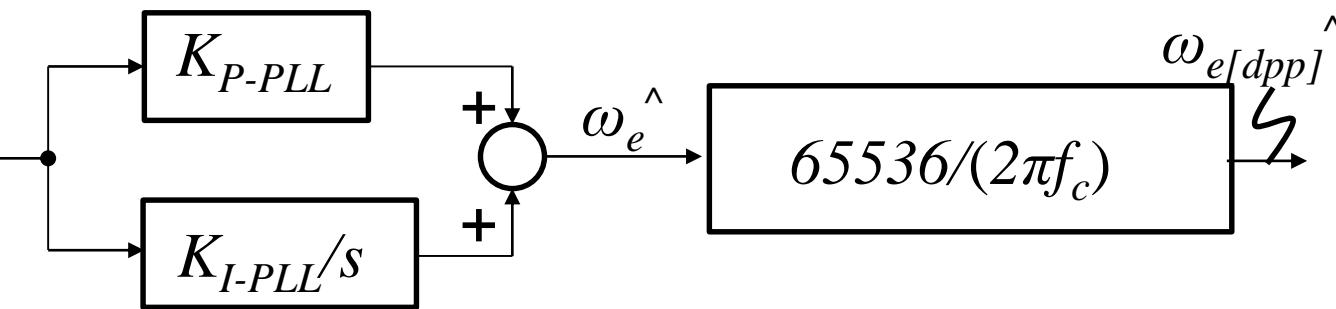
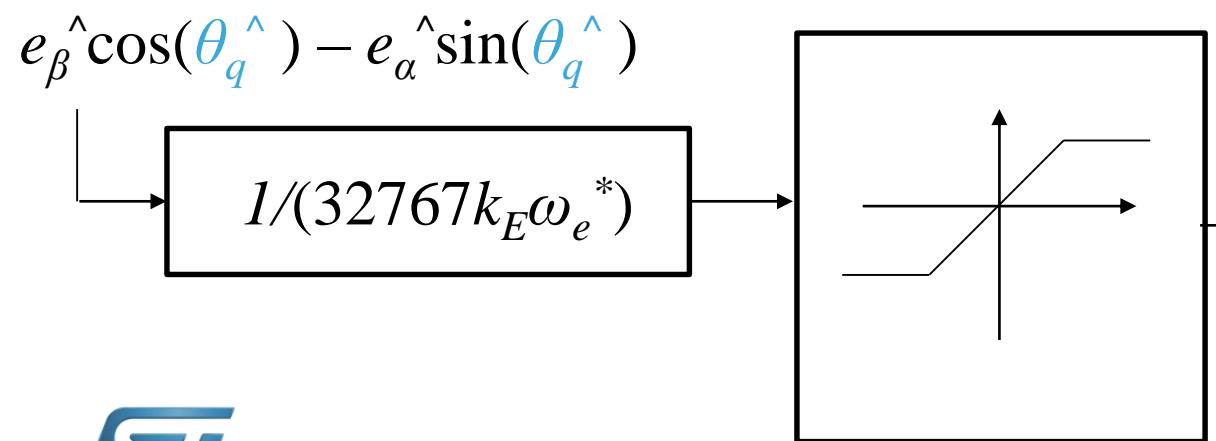
如果 $\theta_q^ - \theta_q$ 比较小

$$\theta_q^ - \theta_q \approx (e_\beta \cos(\theta_q^) - e_\alpha \sin(\theta_q^)) / (k_E \omega_e)$$

位置速度检测 — 观测器(10/13)

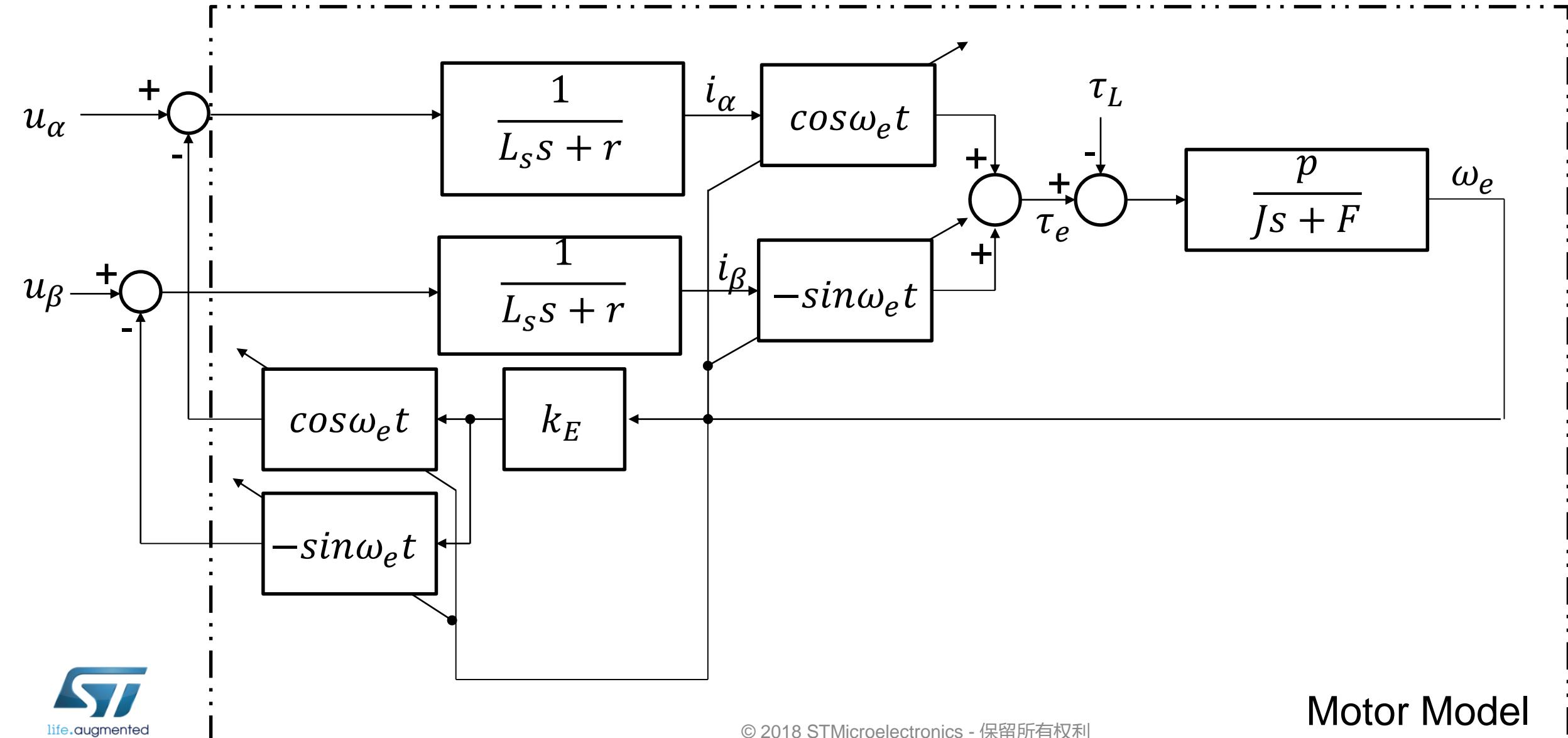


$$\left\{ \begin{array}{l} e = \sqrt{e_\alpha^{\wedge 2} + e_\beta^{\wedge 2}} = k_E \omega_e^* \\ K_{P-PLL} = \omega_n \\ K_{I-PLL} = \frac{K_{P-PLL} \omega_n}{(2\zeta)^2} \end{array} \right.$$

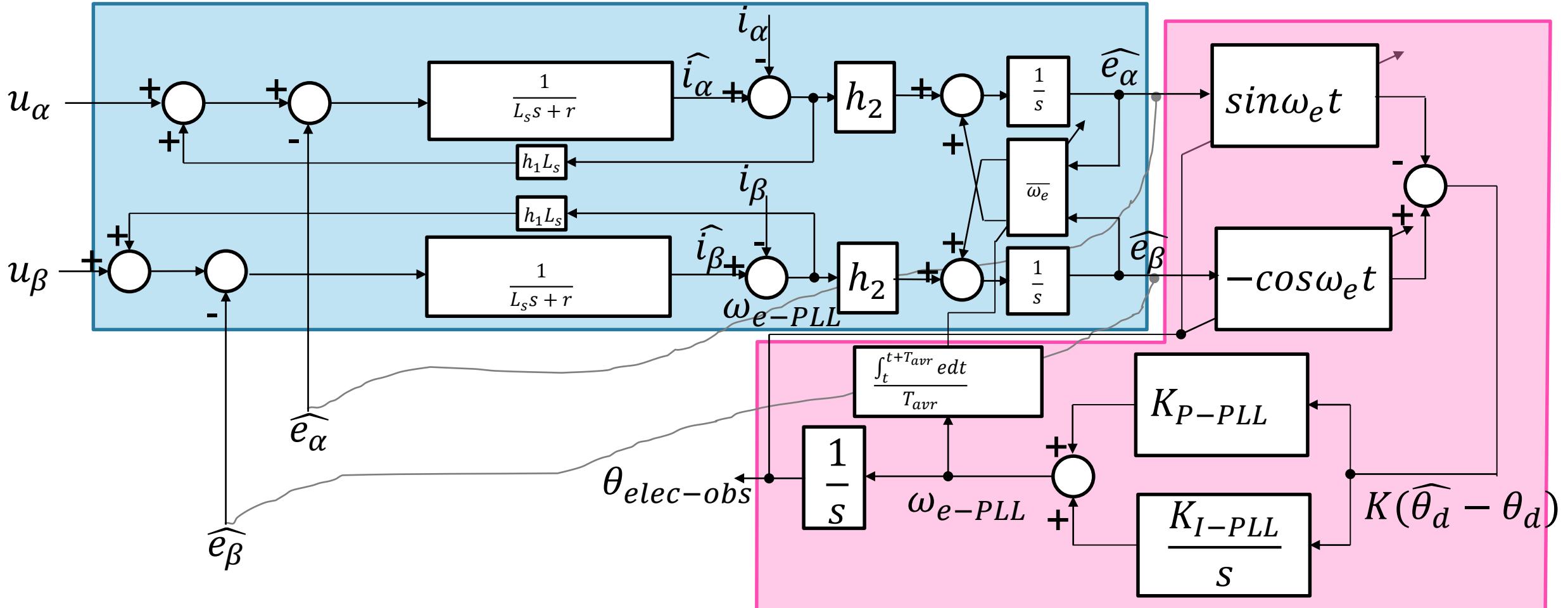


位置速度检测 — 观测器(11/13)

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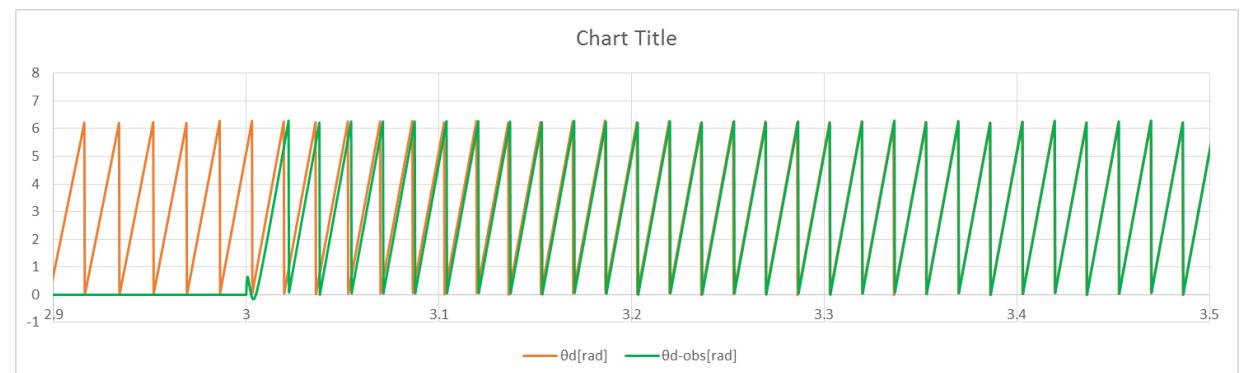
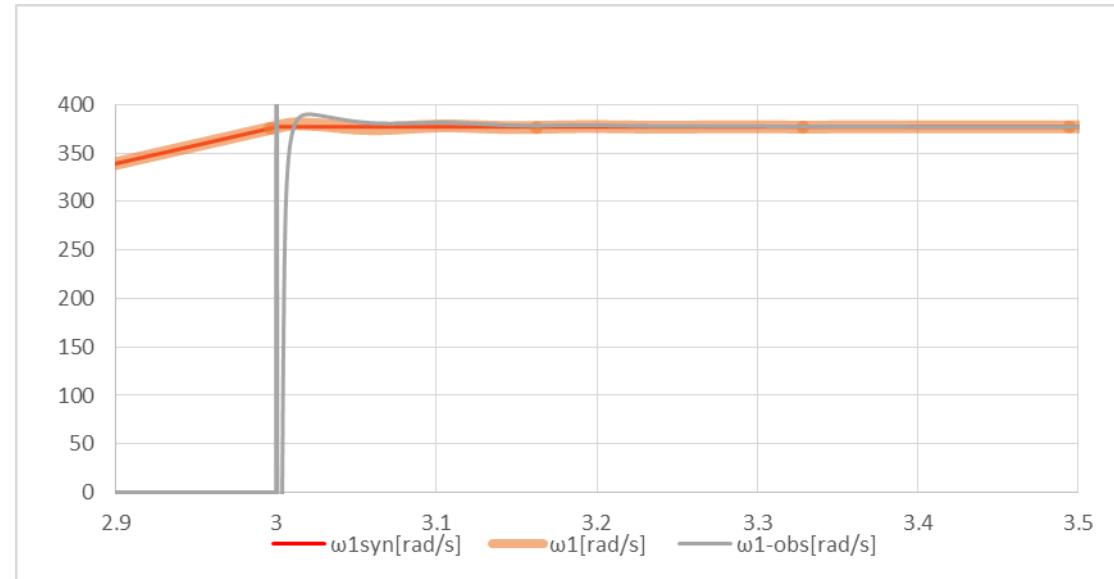
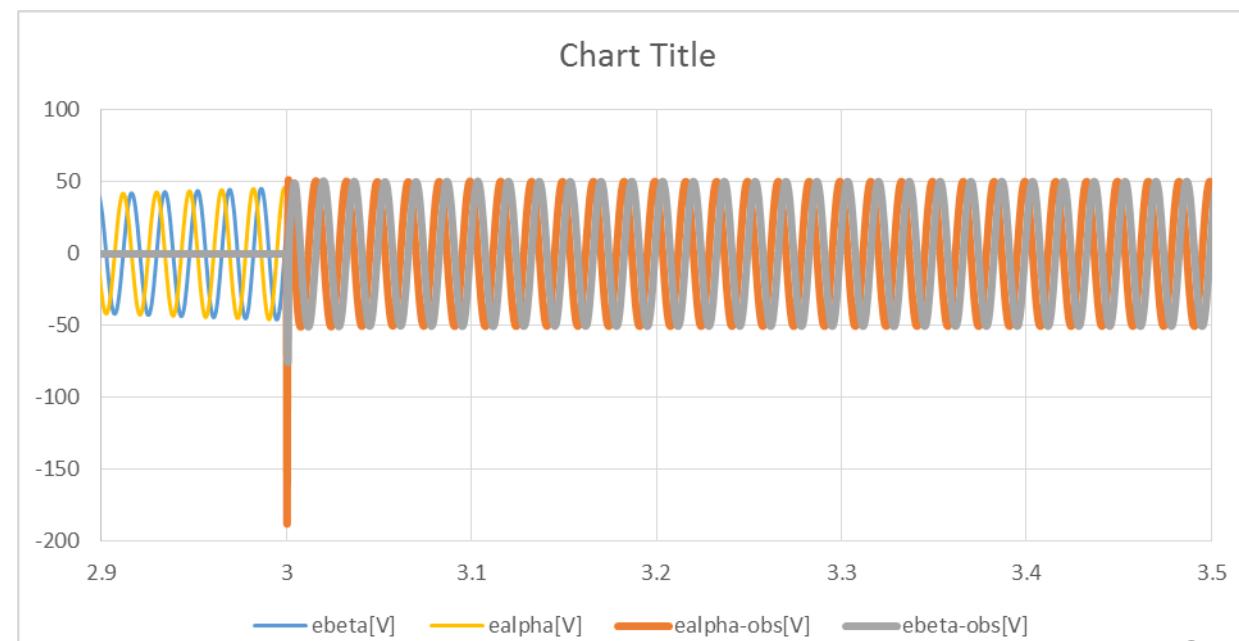
位置速度检测 — 观测器(12/13)



位置速度检测 — 观测器(13/13)

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$$\begin{cases} \hat{i}_\alpha[k] = \left(1 - \frac{rT_s}{L_s} + h_1 T_s\right) \hat{i}_\alpha[k-1] - \frac{T_s}{L_s} \hat{e}_\alpha[k-1] + \frac{T_s}{L_s} u_\alpha[k-1] + h_1 T_s i_\alpha[k-1] \\ \hat{i}_\beta[k] = \left(1 - \frac{rT_s}{L_s} + h_1 T_s\right) \hat{i}_\beta[k-1] - \frac{T_s}{L_s} \hat{e}_\beta[k-1] + \frac{T_s}{L_s} u_\beta[k-1] + h_1 T_s i_\beta[k-1] \\ \hat{e}_\alpha[k] = \hat{e}_\alpha[k-1] + T_s \bar{\omega}_1 \hat{e}_\beta[k-1] + h_2 T_s (\hat{i}_\alpha[k-1] - i_\alpha[k-1]) \\ \hat{e}_\beta[k] = \hat{e}_\beta[k-1] - T_s \bar{\omega}_1 \hat{e}_\alpha[k-1] + h_2 T_s (\hat{i}_\beta[k-1] - i_\beta[k-1]) \end{cases}$$



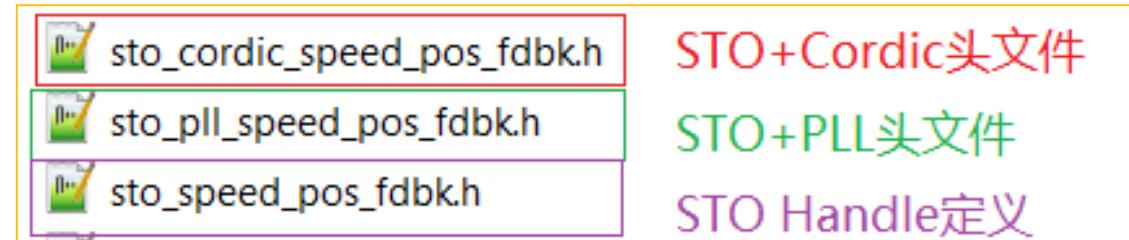
ST MC SDK5.x 观测器STO的固件

➤ 对于X-CUBE-MCSDK：观测器的固件以库的形式提供。

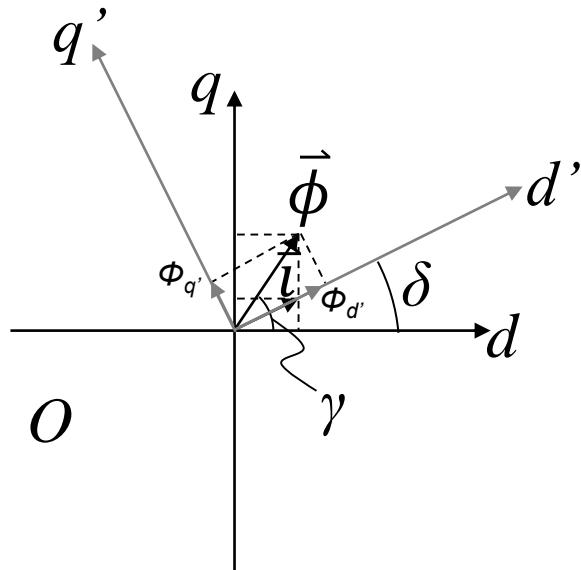
- ✓ xxx\MCSDK_v5.2.0\MotorControl\lib

➤ 头文件名如下：

- ✓ sto_cordic_speed_pos_fdbk.h
- ✓ sto_pll_speed_pos_fdbk.h
- ✓ sto_speed_pos_fdbk.h



位置速度检测 — HFI(1/4)

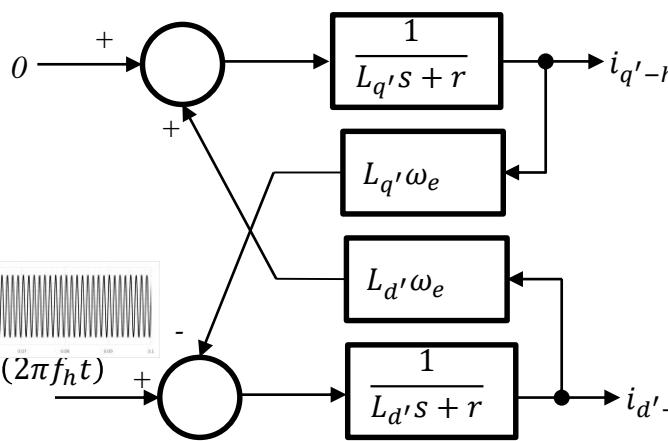
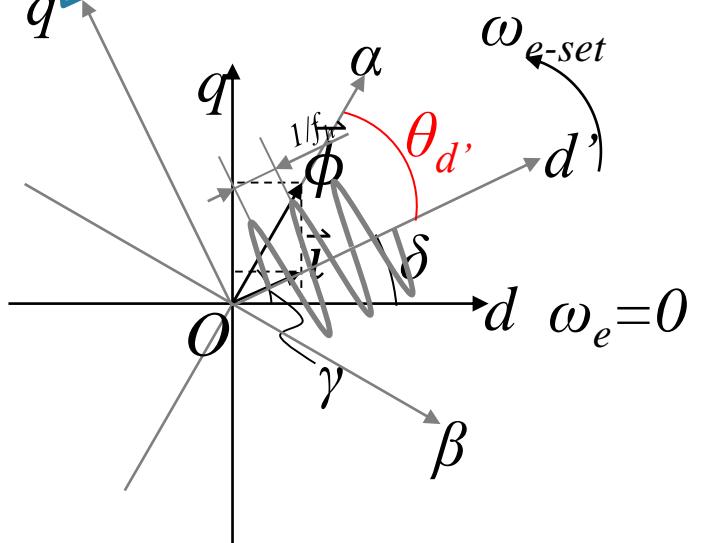


$$\tan \delta = \frac{I_q}{I_d}, \tan \gamma = \frac{L_q I_q}{L_d I_d} = \frac{L_q}{L_d} \tan \delta$$

$$\tan(\gamma - \delta) = \frac{\tan \gamma - \tan \delta}{1 + \tan \gamma \tan \delta} = \frac{\left(\frac{L_q}{L_d} - 1\right) \tan \delta}{1 + \frac{L_q}{L_d} \tan^2 \delta} = \frac{(L_q - L_d) \sin 2\delta}{2[L_d + (L_q - L_d) \sin^2 \delta]}$$

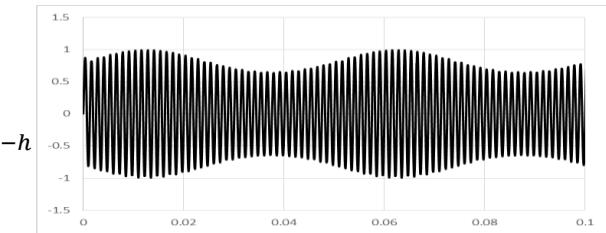
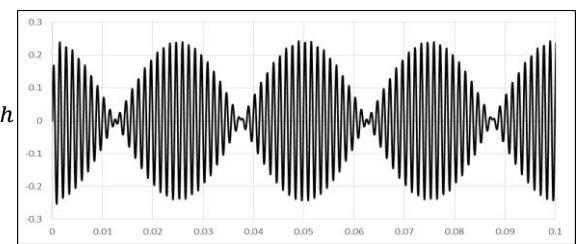
$$|\vec{\phi}| = \sqrt{(L_d I_d)^2 + (L_q I_q)^2} = |\vec{l}| \sqrt{L_d^2 + (L_q^2 - L_d^2) \sin^2 \delta}$$

位置速度检测 — HFI(2/4)

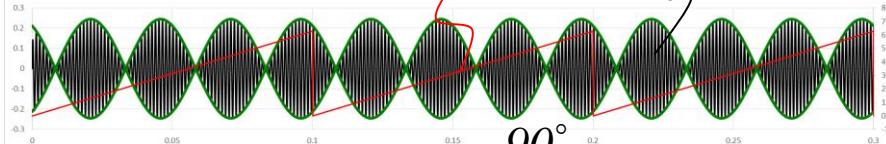


$$|\vec{\phi}| = \sqrt{(L_d I_d)^2 + (L_q I_q)^2} = |\vec{i}| \sqrt{L_d^2 + (L_q^2 - L_d^2) \sin^2 \delta}$$

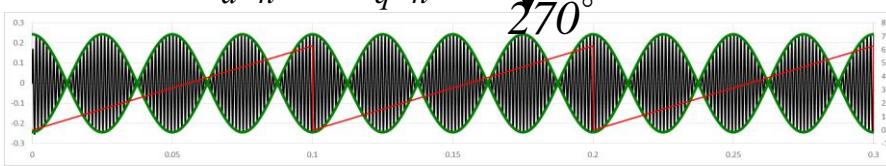
$$|\vec{\phi}| = I_m \sin(2\pi f_h t) \sqrt{L_d^2 + (L_q^2 - L_d^2) \sin^2(\omega_e t + \delta_0)}$$



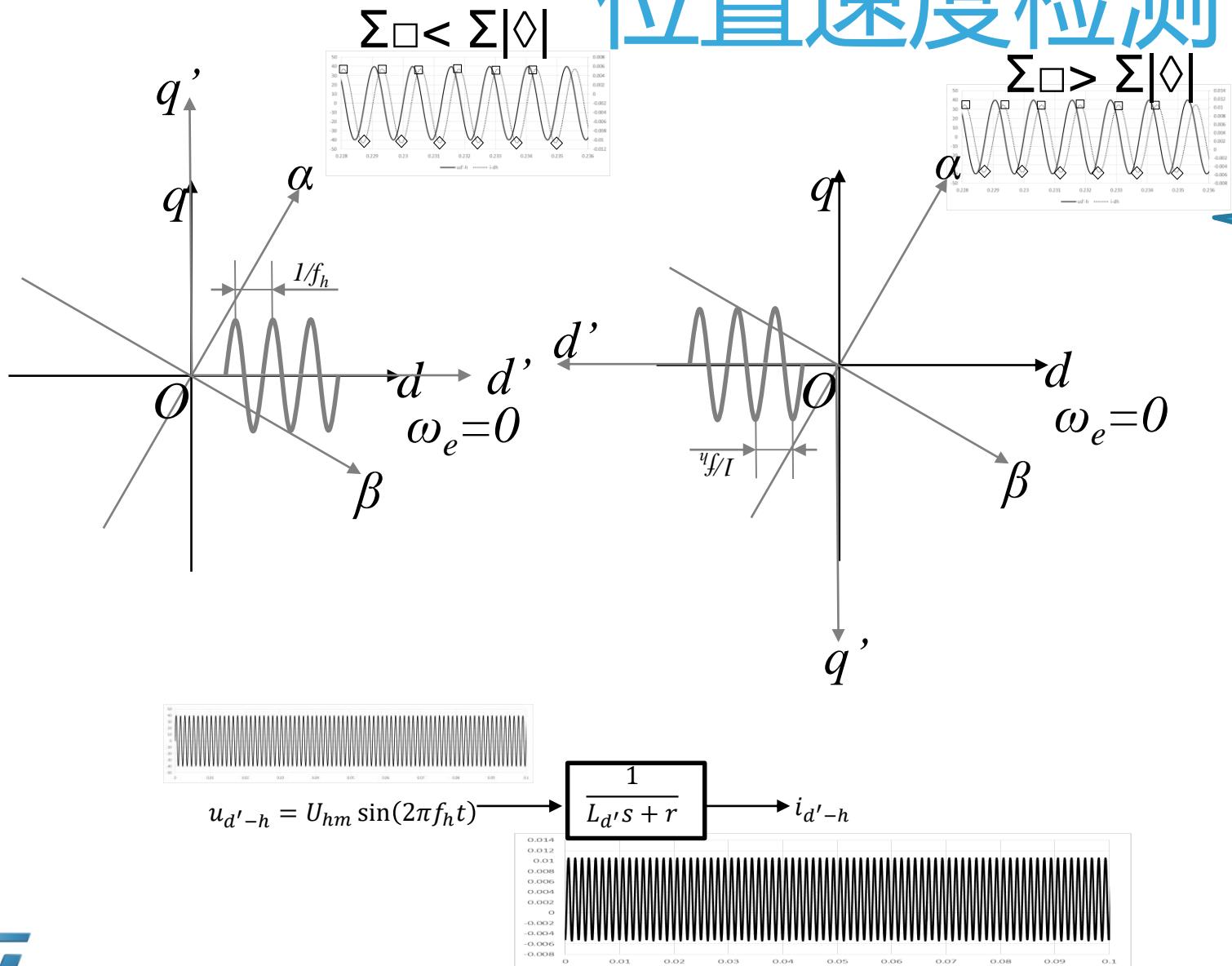
$\theta_d = 30^\circ$ $\theta_{d'} = \int \omega_{e-set} dt$ $i_{q'-h}$



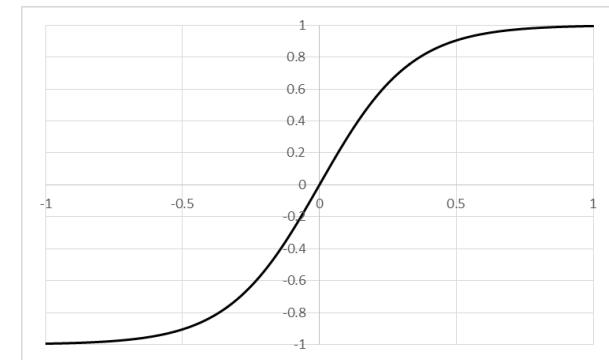
$\theta_d = 45^\circ$ $i_{d'-h} < 0, i_{q'-h} > 0$ 90° $i_{d'-h} > 0, i_{q'-h} > 0$



位置速度检测 — HFI(3/4)

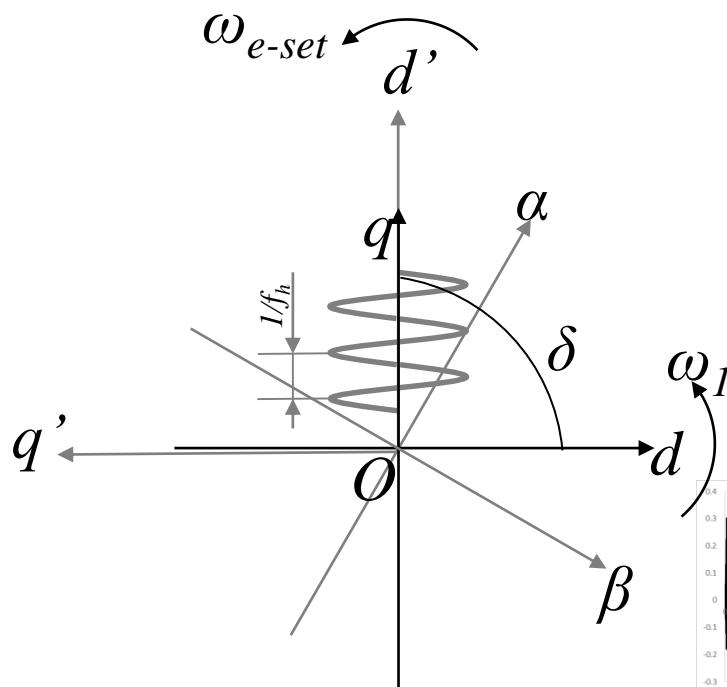


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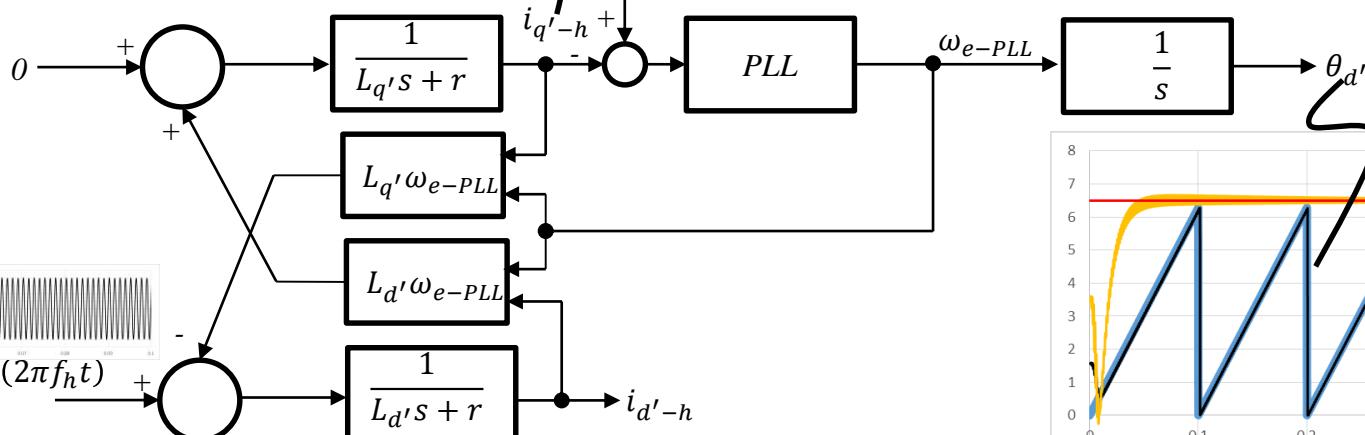
Φ - i 曲线

位置速度检测 — HFI(4/4)



当电机开始转动后，保持 $\delta=0$ ， d' 轴与 q 轴重合，那么 $i_{q'-h}=0$ ，也就是说如果保持 $i_{q'-h}=0$ ， $d'-q'$ 旋转坐标系的速度等于转子速度 $\omega_e = \omega_{e-set}$.

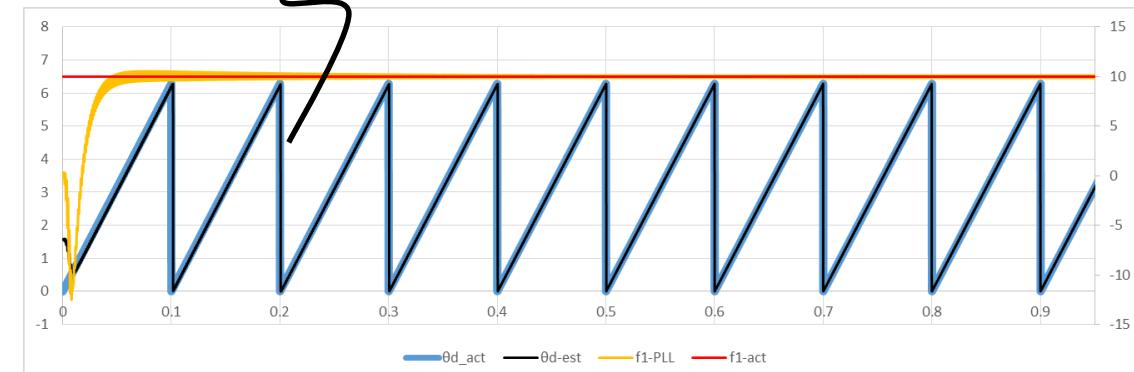
↔ 使用PLL,使得 $i_{q'-h} = 0$



$$u_{d'-h} = U_{hm} \sin(2\pi f_h t)$$



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Releasing your creativity

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- Thank you -

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